

EN25F20A (2N) 2 Megabit Serial Flash Memory with 4Kbyte Uniform Sector

FEATURES

- Single power supply operation
- Full voltage range: 2.7-3.6 volt
- Serial Interface Architecture
- SPI Compatible: Mode 0 and Mode 3
- 2 M-bit Serial Flash
- 2 M-bit/256 K-byte/1,024 pages
- 256 bytes per programmable page
- Standard, Dual or Quad SPI
- Standard SPI: CLK, CS#, DI, DO, WP#, HOLD#
- Dual SPI: CLK, CS#, DQ₀, DQ₁, WP#, HOLD#
- Quad SPI: CLK, CS#, DQ₀, DQ₁, DQ₂, DQ₃
- High performance
- 104MHz clock rate for Standard SPI
- 104MHz clock rate for two data bits
- 104MHz clock rate for four data bits
- Low power consumption
- 6mA typical active current
- 1µA typical power down current
- Uniform Sector Architecture:
- 64 sectors of 4-Kbyte
- 8 blocks of 32-Kbyte
- 4 blocks of 64-Kbyte
- Any sector or block can be erased individually

- Software and Hardware Write Protection:
- Write Protect all or portion of memory via software
- Enable/Disable protection with WP# pin
- High performance program/erase speed
- Page program time: 0.7ms typical
- Sector erase time: 50ms typical
- 32KB Block erase time 150ms typical
- 64KB Block erase time 200ms typical
- Chip erase time: 1.5 seconds typical
- OTP
- 3 sets of OTP lockable 512 byte security sectors
- Support Serial Flash Discoverable Parameters (SFDP) signature
- Read Unique ID Number
- Volatile Status Register Bits
- Minimum 100K endurance cycle
- Data retention time 20 years
- Package Options
- 8 pins SOP 150mil body width
- 8 contact USON 2x3x0.45 mm
- All Pb-free packages are compliant RoHS, Halogen-Free and REACH.

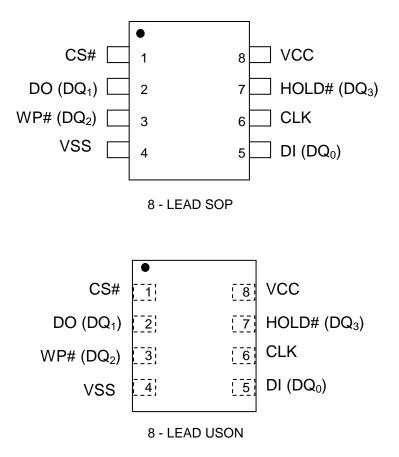
GENERAL DESCRIPTION

The device is a 2 Megabit (256 K-byte) Serial Flash memory, with enhanced write protection mechanisms. The device supports the standard Serial Peripheral Interface (SPI), and a high performance Dual/Quad output as well as Dual/Quad I/O using SPI pins: Serial Clock, Chip Select, Serial DQ₀(DI), DQ₁(DO), DQ₂(WP#) and DQ₃(HOLD#). SPI clock frequencies of up to 104MHz are supported allowing equivalent clock rates of 208MHz (104MHz x 2) for Dual Output and 416MHz (104MHz x 4) for Quad Output when using the Dual/Quad I/O Fast Read instructions. The memory can be programmed 1 to 256 bytes at a time, using the Page Program instruction.

The device is designed to allow either single Sector/Block at a time or full chip erase operation. The device can be configured to protect part of the memory as the software protected mode. The device can sustain a minimum of 100K program/erase cycles on each sector or block.



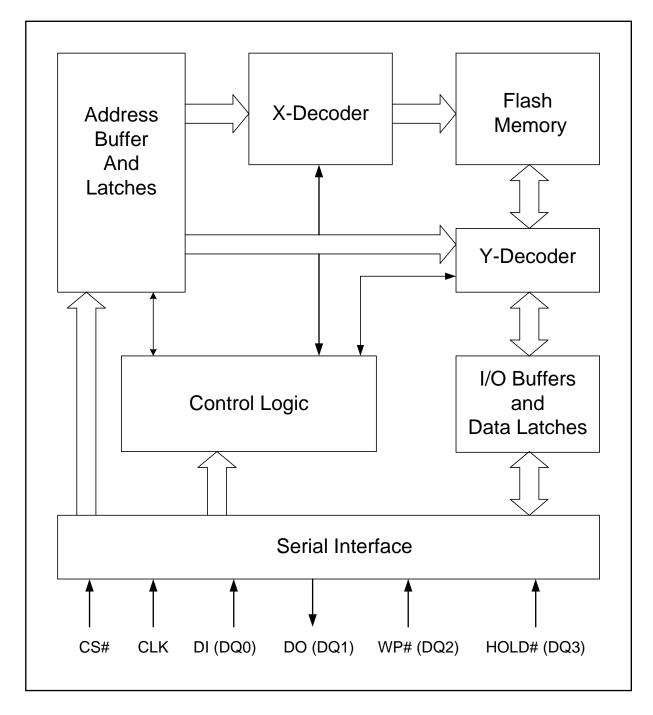
Figure.1 CONNECTION DIAGRAMS (TOP VIEW)



This Data Sheet may be revised by subsequent versions or modifications due to changes in technical specifications.



Figure 2. BLOCK DIAGRAM



Note:

- 1. DQ_0 and DQ_1 are used for Dual and Quad instructions.
- 2. $DQ_0 \sim DQ_3$ are used for Quad instructions.



Table 1. Pin Names

Symbol	Pin Name
CLK	Serial Clock Input
DI (DQ ₀)	Serial Data Input (Data Input Output 0) ^{*1}
DO (DQ ₁)	Serial Data Output (Data Input Output 1) ^{*1}
CS#	Chip Select
WP# (DQ ₂)	Write Protect (Data Input Output 2) ^{*2}
HOLD# (DQ ₃)	HOLD# pin (Data Input Output 3) ^{*2}
V _{CC}	Supply Voltage (2.7-3.6V)
V _{SS}	Ground
NC	No Connect

Note:

1. DQ_0 and DQ_1 are used for Dual and Quad instructions.

2. $DQ_2 \sim DQ_3$ are used for Quad instructions.

SIGNAL DESCRIPTION

Serial Data Input, Output and IOs (DI, DO and DQ₀, DQ₁, DQ₂, DQ₃)

The device support standard SPI, Dual SPI and Quad SPI operation. Standard SPI instructions use the unidirectional DI (input) pin to serially write instructions, addresses or data to the device on the rising edge of the Serial Clock (CLK) input pin. Standard SPI also uses the unidirectional DO (output) to read data or status from the device on the falling edge CLK.

Dual and Quad SPI instruction use the bidirectional IO pins to serially write instruction, addresses or data to the device on the rising edge of CLK and read data or status from the device on the falling edge of CLK.

Serial Clock (CLK)

The SPI Serial Clock Input (CLK) pin provides the timing for serial input and output operations. ("See SPI Mode")

Chip Select (CS#)

The SPI Chip Select (CS#) pin enables and disables device operation. When CS# is high the device is deselected and the Serial Data Output (DO, or DQ_0 , DQ_1 , DQ_2 and DQ_3) pins are at high impedance. When deselected, the devices power consumption will be at standby levels unless an internal erase, program or status register cycle is in progress. When CS# is brought low the device will be selected, power consumption will increase to active levels and instructions can be written to and data read from the device. After power-up, CS# must transition from high to low before a new instruction will be accepted.

Hold (HOLD#)

The HOLD# pin allows the device to be paused while it is actively selected. When HOLD# is brought low, while CS# is low, the DO pin will be at high impedance and signals on the DI and CLK pins will be ignored (don't care). The hold function can be useful when multiple devices are sharing the same SPI signals. The HOLD# function is only available for standard SPI and Dual SPI operation, when during Quad SPI, this pin is the Serial Data IO (DQ₃) for Quad I/O operation.



Write Protect (WP#)

The Write Protect (WP#) pin enables the lock-down function of the Status Register Protect (SRP) bits in the Status Register. When WP# is driven low, the execution of the Write Status Register (WRSR) instruction is determined by the value of the SRP bit (see Table 2). When WP# is high, the lock-down function of the SRP bit is disabled.

Table 2: Conditions to Execute	Write-Status- Register	(WRSR) Instruction
	mino otatao nogiotoi	

WP#	SRP	Execute WRSR Instruction
L	1	Not Allowed
L	0	Allowed
Н	Х	Allowed

MEMORY ORGANIZATION

The memory is organized as:

- 262,144 bytes
- Uniform Sector Architecture 8 blocks of 32-Kbyte 4 blocks of 64-Kbyte 64 sectors of 4-Kbyte
- 1,024 pages (256 bytes each)

Each page can be individually programmed (bits are programmed from 1 to 0). The device is Sector, Block or Chip Erasable but not Page Erasable.



Table 3.	Uniform	Block Sector	Architecture
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3 3	64KB Block	32KB Block	Sector	Address range			64KB Block	32KB Block	Sector	Addres	s range
3 03F400h 03F7Fh 03F00h 03F7Fh 03F00h 03F7Fh 038C00h 038FFh 038C0h 038FFh 03800h 0385FFh 03800h 0383FFh 03800h 0383FFh 03800h 0383FFh 03800h 0387FFh 03800h 037FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03700h 030FFFh 03700h 030FFFh 03700h 030FFFh 03700h 030FFFh 03000h 030FFFh 03000h 030FFFh 03000h 030FFFh 03000h 030FFFh 03000h 030FFFh 03000h 030FFFh 03000h 028FFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02F00h 028FFFh 02800h 0288FFh 02800h 0288FFh 02800h 0288FFh 02800h 0288FFh 02800h 0285FFh 02800h 0285FFh 027000h 0275FFh 027000h 0275FFh 027000h 0275FFh				03FC00h	03FFFFh					01FC00h	01FFFFh
1 03F4000 03F7FFh 03F0000 03F7FFh 03F0000 03F0000 03F7FFh 03F0000 03F7FFh 0380000 038FFFh 0380000 038FFFh 0380000 038FFFh 0380000 038FFFh 0380000 038FFFh 0380000 038FFFh 0380000 038FFFh 037000 037FFFh 0370000 037FFFh 037000 037FFFh 0370000 037FFFh 037000 037FFFh 0370000 037FFFh 037000 037FFFh 0370000 037FFFh 037000 037FFFh 0370000 0303FFFh 0170000 017FFFh 0300000 0303FFFh 0170000 0177FFh 0300000 0303FFFh 0100000 0103FFFh 0300000 0303FFFh 0100000 0103FFFh 03030000 027FFFh 02F0000 02FFFFh 0303000 02FFFFh 02F0000 02FFFFh 02F0000 02FFFFh 02F0000 <t< td=""><td></td><td></td><td>62</td><td>03F800h</td><td>03FBFFh</td><td></td><td></td><td></td><td>24</td><td>01F800h</td><td>01FBFFh</td></t<>			62	03F800h	03FBFFh				24	01F800h	01FBFFh
3			63	03F400h	03F7FFh				31	01F400h	01F7FFh
3				03F000h	03F3FFh					01F000h	01F3FFh
3 56 03800h 038FFh 03800h 0387FFh 03800h 0383FFh 03800h 0387FFh 03800h 0387FFh 03700h 037FFFh 03700h 0377FFh 03700h 0373FFh 03700h 0373FFh 03700h 037FFh 03700h 037FFh 03700h 037FFh 03000h 0308FFh 03000h 028FFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 02800h 028FFFh 02800h 028FFFh 02800h 028FFFh 02800h 028FFFh 02800h 028FFFh 02800h 028FFFh 027400h 027FFFh 027400h 027FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFFh 007600h 007FFh 007600h 007FFh		7			:			3			
3 56 038400h 0387FFh 018400h 0187FFh 3 3 3 037C00h 037FFFh 018000h 0183FFh 3 3 3 037C00h 037FFFh 017C00h 017FFFh 03700h 037700h 0377FFh 03700h 0377FFh 01700h 017FFFh 03700h 03730FFFh 03700h 037FFFh 03700h 037FFFh 01700h 017FFFh 03700h 0377FFh 03700h 037FFFh 03000h 030FFFh 01700h 017FFFh 03700h 037FFFh 03000h 030FFFh 03000h 030FFFh 010000h 0107FFFh 03000h 0303FFFh 03000h 030FFFh 03000h 030FFFh 010000h 0107FFFh 03000h 026F00h 02FFFFh 02F00h 02FFFFh 00FC0h 00FFFFh 02F00h 02FFFFh 02F00h 02FFFFh 00F00h 00FFFFh 02800h 028FFFh 02800h 028FFFh				038C00h	038FFFh					018C00h	018FFFh
3 038400h 0387FFh 038000h 0383FFh 038000h 0383FFh 037000h 037FFFh 037000h 037FFFh 037000h 0377FFh 037000h 0377FFh 037000h 0377FFh 037000h 0377FFh 037000h 0307FFh 030000h 0308FFh 030400h 0307FFh 030400h 0307FFh 030400h 0307FFh 030400h 0307FFh 030400h 0307FFh 030400h 0307FFh 02600h 027FFFh 02600h 028FFFh 02600h 028FFFh 02600h 028FFFh 02800h 028FFFh 00800h 008FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFh 00700h 007FFh 000000h 000FFFh 00000h 000FFFh 000000h 000FFFh 00000h 000FFFh 00000h 000FFh <td></td> <td></td> <td>50</td> <td>038800h</td> <td>038BFFh</td> <td></td> <td></td> <td></td> <td>24</td> <td>018800h</td> <td>018BFFh</td>			50	038800h	038BFFh				24	018800h	018BFFh
3 037C00h 037FFFh 037800h 037FFFh 037400h 0377FFh 037000h 0373FFh 037000h 0373FFh 037000h 0373FFh 037000h 0373FFh 037000h 0373FFh 030000h 0303FFh 030000h 0303FFh 030000h 0303FFh 030000h 0303FFh 030000h 0303FFh 030000h 0303FFh 030000h 0303FFh 030000h 027FFFh 02F800h 02FFFFh 02F800h 02FFFFh 02F800h 02FFFFh 02F800h 02F3FFh 028000h 0283FFh 028000h 0283FFh 008000h 0083FFh 008000h 0083FFh 00800h 0083FFh 00700h 0077FFh 00700h 0077FFh 0000000 000FFh			90	038400h	0387FFh				24	018400h	0187FFh
2 5	2			038000h	0383FFh		4			018000h	0183FFh
2	3			037C00h	037FFFh		1			017C00h	017FFFh
2				037800h	037BFFh				22	017800h	017BFFh
6 i i i i i ii iii iiiiii iiii			55	037400h	0377FFh				23	017400h	0177FFh
2 48				037000h	0373FFh					017000h	0173FFh
2 48 030800h 0308FFh 16 010800h 0108FFh 030400h 0303FFh 010400h 0107FFh 010000h 0103FFh 030000h 0303FFh 02FC00h 02FFFFh 02F800h 02FBFFh 02F800h 02F8FFh 02F000h 02FFFFh 00FC00h 00FFFFh 02F000h 02F7FFh 02F000h 02F8FFh 00F000h 00F3FFh 02F000h 02F3FFh 02800h 028FFFh 00F000h 00F3FFh 028000h 0288FFFh 028000h 028FFFh 00800h 0088FFFh 028000h 0287FFFh 028000h 0287FFFh 00800h 0088FFFh 028000h 0288FFFh 028000h 0287FFFh 008800h 0088FFFh 028000h 0287FFFh 028000h 0287FFFh 008800h 00880FFFh 008000h 0287FFFh 027800h 027FFFFh 00800h 0088FFFh 027400h 0277FFFh 027400h 0277FFFh 007400h 0077FFFh		6						2			
2 48 030400h 0307FFh 010400h 0107FFh 030000h 0303FFh 010400h 0103FFh 010400h 0103FFh 030000h 0303FFh 02FC00h 02FFFFh 010400h 0103FFh 02F400h 02FFFFh 02F800h 02FFFFh 00FC00h 00FFFFh 02F400h 02F7FFh 02F000h 02F3FFh 00F000h 00F3FFh 5 ii iii iii iii iii iii iii 40 028000h 028FFFh 02800h 028FFFh 00800h 0080FFFh 028000h 0283FFFh 028000h 028FFFh 00800h 0083FFFh 028000h 0283FFFh 027600h 027FFFFh 00800h 0083FFFh 027800h 0278FFFh 027800h 027FFFFh 007600h 0077FFFh 027800h 0277FFFh 027000h 027FFFFh 007600h 0077FFFh 027800h 0277FFFh 027000h 0277FFFh 007000h 0077F				030C00h	030FFFh					010C00h	010FFFh
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2 47 02FC00h 02FFFh 02F800h 02FBFh 02F400h 02F7FFh 02F400h 02F7FFh 02F000h 02F3FFh 028C00h 028FFFh 028C00h 028FFFh 028C00h 028FFFh 02800h 0288FFh 02800h 0283FFh 02800h 0283FFh 02800h 0283FFh 02800h 027FFFh 02800h 027FFFh 02800h 027FFFh 02800h 0277FFh 02700h 0277FFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00700h 007FFFh 00000h 000FFFh 00000h 000FFFh 00000h 000FFFh 00000h 000FFFh 00000h 000FFFh 00000h 000FFFh 00000h 000FFFh			48	030400h	0307FFh				10	010400h	0107FFh
2 47 02F800h 02FBFFh 02F400h 02F7FFh 02F000h 02F3FFh 02F000h 02F3FFh 02F000h 02F3FFh 02800h 028FFFh 028800h 028BFFh 028800h 028BFFh 02800h 0283FFh 02800h 0283FFh 02800h 0283FFh 02800h 027FFh 027400h 0277FFh 027400h 0277FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0273FFh 027400h 0277FFh 027400h 0273FFh 027400h 0273FFh 027400h 0277FFh 027400h 0277FFh 007800h 007FFh 007800h 000FFFh 007400h 0077FFh 007400h 0077FFh 007400h 0077FFh 007400h 0077FFh 007400h 0077FFh 007400h 0077FFh 007400h 000FFFh 007400h 000FFFh 007400h 000FFFh 007400h 000FFFh				030000h	0303FFh					010000h	0103FFh
2 47 02F400h 02F7FFh 02F000h 02F3FFh 00F400h 00F7FFh 02F000h 02F3FFh 02F000h 02F3FFh 1 i ii iii 40 02800h 028FFFh 02800h 028FFFh 02800h 0283FFh 02800h 0283FFh 02800h 0283FFFh 02800h 0283FFFh 02800h 0283FFFh 02800h 0283FFFh 02800h 02780FFFh 02700h 027FFFh 027400h 0277FFFh 027400h 0277FFFh 027400h 0277FFFh 027400h 0277FFFh 027400h 0277FFFh 027400h 0277FFFh 027400h 0273FFFh 007600h 0077FFFh 027000h 02073FFFh 007000h 0073FFFh 000000h 0000FFFh 007000h 0073FFFh 000000h 0200FFFh 00000h 0000FFFh 000000h 0200FFFh 00000h 0000FFFh 0				02FC00h	02FFFFh					00FC00h	00FFFFh
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2			47	02F400h	02F7FFh				15	00F400h	00F7FFh
2 028C00h 028FFFh 40 028800h 028FFFh 028400h 0283FFh 028000h 0283FFh 028000h 0283FFh 028000h 0283FFh 028000h 0283FFh 027C00h 027FFFh 027800h 027FFFh 027400h 0277FFFh 027000h 027FFFh 027000h 0207FFFh 027000h 020FFFh 0202000h 020FFFh 020800h 0208FFFh 020800h 0208FFFh 020800h 0208FFFh 020800h 0208FFFh 020800h 0208FFFh 0202000h 0208FFFh<				02F000h	02F3FFh					00F000h	00F3FFh
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2 40 028400h 0287FFh 008400h 0087FFh 028000h 0283FFh 028000h 0283FFh 008000h 0083FFh 39 027C00h 027FFFh 027800h 027FFFh 007800h 007FFFh 027400h 0277FFh 027000h 0277FFFh 007400h 0077FFFh 027000h 0273FFFh 027000h 0277FFFh 007400h 0077FFFh 027000h 02077FFFh 02000h 020FFFFh 007400h 0077FFFh 32 020000h 020FFFFh 000000h 0000FFFh 000000h 0000FFFh 000000h 0200FFFh 020400h 0207FFFh 000000h 0000FFFh 000400h 0000FFFh 000400h 0007FFFh 000400h 0007FFFh				028C00h	028FFFh					008C00h	008FFFh
2 028400h 0287FFh 008400h 0083FFh 2 028000h 0283FFh 008000h 0083FFh 39 027C00h 027FFFh 007C00h 007FFFh 027400h 0277FFh 027000h 0277FFh 007400h 007FFFh 027000h 0277FFh 027000h 0277FFh 007400h 0077FFh 027000h 0273FFFh 027000h 0277FFh 007000h 0077FFh 027000h 0207FFFh 02000h 020FFFh 00000h 0007FFFh 32 02000h 0208FFh 020800FFFh 00000h 0000FFFh 000400h 0207FFFh 020400h 0207FFFh 000400h 0007FFFh			10	028800h	028BFFh					008800h	008BFFh
2 027C00h 027FFFh 0 0 007C00h 007FFFh 39 027800h 027BFFh 027400h 0277FFh 007800h 007BFFh 007800h 007BFFh 4 1 1 1 1 1 1 32 020C00h 020FFFh 00000h 020FFFh 00000h 000FFFh 000000h 000FFFh 000000h 020FFFh 020800h 020FFFh 000000h 000FFFh 000000h 000FFFh 000000h 020FFFh 000000h 000FFFh 000000h 000FFFh 000000h 000FFFh 000000h 000FFFh 000000h 000FFFh			40	028400h	0287FFh				8	008400h	0087FFh
4 <u>i</u> <u>i</u>				028000h	0283FFh					008000h	0083FFh
4 ³⁹ ^{027400h} 0277FFh ^{0273FFh} ^{0273FFh} ^{027000h} 0273FFh ^{007400h} 0077FFh ^{007400h} 0073FFh ^{007000h} 0073FFh ^{007000h} 0073FFh ^{0007000h} 0073FFh ^{0007000h} 0007FFh ^{000800h} 000FFFh ^{000800h} 0008FFh ^{000800h} 0008FFh ^{000800h} 0008FFh ^{000400h} 0007FFh ^{000400h} 00007FFh ^{000400h} 00007FFh ^{00040h} 000	2			027C00h	027FFFh		0			007C00h	007FFFh
4 027400h 0277FFh 027000h 0273FFh 1 1 20000h 0273FFh 007000h 0073FFh 1 1 1				027800h	027BFFh				-	007800h	007BFFh
4 		4	39	027400h	0277FFh				1	007400h	0077FFh
32 020C00h 020FFFh 020800h 020BFFh 020400h 0207FFh				027000h	0273FFh					007000h	0073FFh
32 020800h 020BFFh 020400h 0207FFh 000400h 0007FFh								0			
32 020400h 0207FFh 0000400h 0007FFh				020C00h	020FFFh					000C00h	000FFFh
020400h 0207FFh 000400h 0007FFh			~~	020800h	020BFFh				_	000800h	000BFFh
020000h 0203FFh 000000h 0003FFh			32	020400h	0207FFh				0	000400h	0007FFh
				020000h	0203FFh					000000h	0003FFh



OPERATING FEATURES

Standard SPI Modes

The device is accessed through a SPI compatible bus consisting of four signals: Serial Clock (CLK), Chip Select (CS#), Serial Data Input (DI) and Serial Data Output (DO). Both SPI bus operation Modes 0 (0,0) and 3 (1,1) are supported. The primary difference between Mode 0 and Mode 3, as shown in Figure 3, concerns the normal state of the CLK signal when the SPI bus master is in standby and data is not being transferred to the Serial Flash. For Mode 0 the CLK signal is normally low. For Mode 3 the CLK signal is normally high. In either case data input on the DI pin is sampled on the rising edge of the CLK. Data output on the DO pin is clocked out on the falling edge of CLK.

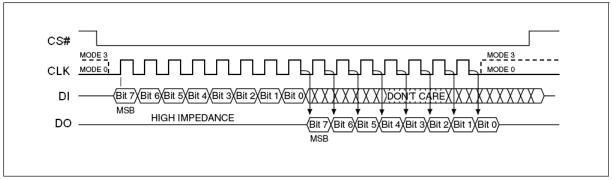


Figure 3. SPI Modes

Dual SPI Instruction

The device supports Dual SPI operation when using the "Dual Output Fast Read and Dual I/O Fast Read" (3Bh and BBh) instructions. These instructions allow data to be transferred to or from the Serial Flash memory at two to three times the rate possible with the standard SPI. The Dual Read instructions are ideal for quickly downloading code from Flash to RAM upon power-up (code-shadowing) or for application that cache code-segments to RAM for execution. The Dual output feature simply allows the SPI input pin to also serve as an output during this instruction. When using Dual SPI instructions the DI and DO pins become bidirectional I/O pins; DQ_0 and DQ_1 . All other operations use the standard SPI interface with single output signal.

Quad I/O SPI Modes

The device supports Quad input / output operation when using the Quad I/O Fast Read (EBh). This instruction allows data to be transferred to or from the Serial Flash memory at four to six times the rate possible with the standard SPI. The Quad Read instruction offer a significant improvement in continuous and random access transfer rates allowing fast code-shadowing to RAM or for application that cache code-segments to RAM for execution. When using Quad SPI instruction the DI and DO pins become bidirectional I/O pins; DQ_0 and DQ_1 and the WP# and HOLD# pins become DQ_2 and DQ_3 respectively.



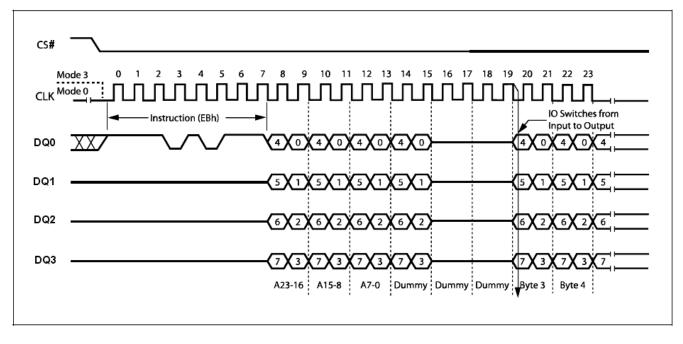
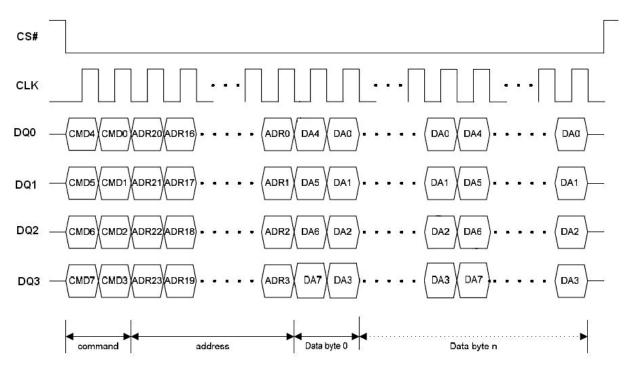
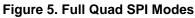


Figure 4. Quad I/O SPI Modes

Full Quad SPI Modes (QPI)

The device also supports Full Quad SPI Mode (QPI) function while using the Enable Quad Peripheral Interface mode (EQPI) (38h). When using Quad SPI instruction the DI and DO pins become bidirectional I/O pins; DQ_0 and DQ_1 , and the WP# and HOLD# pins become DQ_2 and DQ_3 respectively.







Page Programming

To program one data byte, two instructions are required: Write Enable (WREN), which is one byte, and a Page Program (PP) or Quad Input Page Program (QPP) sequence, which consists of four bytes plus data. This is followed by the internal Program cycle (of duration t_{PP}).

To spread this overhead, the Page Program (PP) or Quad Input Page Program (QPP) instruction allows up to 256 bytes to be programmed at a time (changing bits from 1 to 0) provided that they lie in consecutive addresses on the same page of memory.

Sector Erase, Half Block Erase, Block Erase and Chip Erase

The Page Program (PP) or Quad Input Page Program (QPP) instruction allows bits to be reset from 1 to 0. Before this can be applied, the bytes of memory need to have been erased to all 1s (FFh). This can be achieved a sector at a time, using the Sector Erase (SE) instruction, half a block at a time using the Half Block Erase (HBE) instruction, a block at a time using the Block Erase (BE) instruction or throughout the entire memory, using the Chip Erase (CE) instruction. This starts an internal Erase cycle (of duration t_{SE} , t_{HBE} , t_{BE} or t_{CE}). The Erase instruction must be preceded by a Write Enable (WREN) instruction.

Polling During a Write, Program or Erase Cycle

A further improvement in the time to Write Status Register (WRSR), Program (PP, QPP) or Erase (SE, HBE, BE or CE) can be achieved by not waiting for the worst case delay (t_W , t_{PP} , t_{SE} , t_{HBE} , t_{BE} or t_{CE}). The Write In Progress (WIP) bit is provided in the Status Register so that the application program can monitor its value, polling it to establish when the previous Write cycle, Program cycle or Erase cycle is complete.

Active Power, Stand-by Power and Deep Power-Down Modes

When Chip Select (CS#) is Low, the device is enabled, and in the Active Power mode. When Chip Select (CS#) is High, the device is disabled, but could remain in the Active Power mode until all internal cycles have completed (Program, Erase, and Write Status Register). The device then goes into the Stand-by Power mode. The device consumption drops to I_{CC1} .

The Deep Power-down mode is entered when the specific instruction (the Enter Deep Power-down Mode (DP) instruction) is executed. The device consumption drops further to I_{CC2} . The device remains in this mode until another specific instruction (the Release from Deep Power-down Mode and Read Device ID (RDI) instruction) is executed.

All other instructions are ignored while the device is in the Deep Power-down mode. This can be used as an extra software protection mechanism, when the device is not in active use, to protect the device from inadvertent Write, Program or Erase instructions.

Write Protection

Applications that use non-volatile memory must take into consideration the possibility of noise and other adverse system conditions that may compromise data integrity. To address this concern the device provides the following data protection mechanisms:

- Power-On Reset and an internal timer (t_{PUW}) can provide protection against inadvertent changes while the power supply is outside the operating specification.
- Program, Erase and Write Status Register instructions are checked that they consist of a number of clock pulses that is a multiple of eight, before they are accepted for execution.
- All instructions that modify data must be preceded by a Write Enable (WREN) instruction to set the Write Enable Latch (WEL) bit. This bit is returned to its reset state by the following events:
 - Power-up
 - Write Disable (WRDI) instruction completion or Write Status Register (WRSR) instruction completion or Page Program (PP), Quad Input Page Program (QPP) instruction completion or Sector Erase (SE) instruction completion or Half Block Erase (HBE) / Block Erase (BE) instruction completion or Chip Erase (CE) instruction completion
- The Block Protect (BP3, BP2, BP1, BP0) bits allow part of the memory to be configured as readonly. This is the Software Protected Mode (SPM).
- The Write Protect (WP#) signal allows the Block Protect (BP3, BP2, BP1, BP0) bits and Status Register Protect (SRP) bit to be protected. This is the Hardware Protected Mode (HPM).



• In addition to the low power consumption feature, the Deep Power-down mode offers extra software protection from inadvertent Write, Program and Erase instructions, as all instructions are ignored except one particular instruction (the Release from Deep Power-down instruction).

Status Register Content			ntent	Memory Content					
BP3 Bit	BP2 Bit	BP1 Bit	BP0 Bit	Protect Areas	Addresses	Density(KB)	Portion		
0	0	0	0	None	None	None	None		
0	0	0	1	Block 3	030000h-03FFFFh	64KB	Upper 1/4		
0	0	1	0	Block 2 to 3	020000h-03FFFFh	128KB	Upper 2/4		
0	0	1	1	Block 1 to 3	010000h-03FFFFh	192KB	Upper 3/4		
0	1	0	0	All	000000h-03FFFFh	256KB	All		
0	1	0	1	All	000000h-03FFFFh	256KB	All		
0	1	1	0	All	000000h-03FFFFh	256KB	All		
0	1	1	1	All	000000h-03FFFFh	256KB	All		
1	0	0	0	None	None	None	None		
1	0	0	1	Block 0	000000h-00FFFFh	64KB	Lower 1/4		
1	0	1	0	Block 0 to 1	000000h-01FFFFh	128KB	Lower 2/4		
1	0	1	1	Block 0 to 2	000000h-02FFFFh	192KB	Lower 3/4		
1	1	0	0	All	000000h-03FFFFh	256KB	All		
1	1	0	1	All	000000h-03FFFFh	256KB	All		
1	1	1	0	All	000000h-03FFFFh	256KB	All		
1	1	1	1	All	000000h-03FFFFh	256KB	All		

 Table 4. Protected Area Sizes Sector Organization

Enable Boot Lock

The Enable Boot Lock feature enables user to lock the 64KB block/sector on the top/bottom of the device for protection. This feature is activated by issue Writing Status Register (05h) after entering OTP mode.

The bits' definitions are described in the following table.

Table 5. The Enable Boot Lock fe	feature
----------------------------------	---------

Register	Туре	Description	Function					
			0(default)					
S3	OTP	Enable 64KB-block/Sector Boot lock	1: Permanent lock selected 64KB- Block/Sector					
S4	OTP	64KB-Block/Sector switch	0: 64KB-Block(default)					
- 34	OIF	04ND-DIOCK/Sector Switch	1: Sector					
S6	6 OTP Top/Bottom switch		0: Top(default)					
30	OIP	Top/Bottom switch	1: Bottom					

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INSTRUCTIONS

All instructions, addresses and data are shifted in and out of the device, most significant bit first. Serial Data Input (DI) is sampled on the first rising edge of Serial Clock (CLK) after Chip Select (CS#) is driven Low. Then, the one-byte instruction code must be shifted in to the device, most significant bit first, on Serial Data Input (DI), each bit being latched on the rising edges of Serial Clock (CLK).

The instruction set is listed in Table 6. Every instruction sequence starts with a one-byte instruction code. Depending on the instruction, this might be followed by address bytes, or by data bytes, or by both or none. Chip Select (CS#) must be driven High after the last bit of the instruction sequence has been shifted in. In the case of a Read Data Bytes (READ), Read Data Bytes at Higher Speed (Fast_Read), Dual Output Fast Read (3Bh), Dual I/O Fast Read (BBh), Quad Input/Output FAST_READ (EBh), Read Status Register (RDSR) or Release from Deep Power-down, and Read Device ID (RDI) instruction, the shifted-in instruction sequence is followed by a data-out sequence. Chip Select (CS#) can be driven High after any bit of the data-out sequence is being shifted out.

In the case of a Page Program (PP), Quad Input Page Program (QPP), Sector Erase (SE), Half Block Erase (HBE), Block Erase (BE), Chip Erase (CE), Write Status Register (WRSR), Volatile Status Register Write Enable, Write Enable (WREN), Write Disable (WRDI) or Deep Power-down (DP) instruction, Chip Select (CS#) must be driven High exactly at a byte boundary, otherwise the instruction is rejected, and is not executed. That is, Chip Select (CS#) must driven High when the number of clock pulses after Chip Select (CS#) being driven Low is an exact multiple of eight. For Page Program, if at any time the input byte is not a full byte, nothing will happen and WEL will not be reset.

In the case of multi-byte commands of Page Program (PP), Quad Input Page Program (QPP) and Release from Deep Power Down (RES) minimum number of bytes specified has to be given, without which, the command will be ignored.

In the case of Page Program, if the number of byte after the command is less than 4 (at least 1 data byte), it will be ignored too. In the case of SE, HBE and BE, exact 24-bit address is a must, any less or more will cause the command to be ignored.

All attempts to access the memory array during a Write Status Register cycle, Program cycle or Erase cycle are ignored, and the internal Write Status Register cycle, Program cycle or Erase cycle continues unaffected.



Table 6A. Instruction Set

Instruction Name	Byte 1 Code	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6	n-Bytes
EQPI	38h						
RSTQIO ⁽¹⁾ Release Quad I/O or Fast Read Enhanced Mode	FFh						
RSTEN	66h						
RST ⁽²⁾	99h						
Write Enable	06h						
Write Disable / Exit OTP mode	04h						
Read Status Register	05h	(S7-S0) ⁽³⁾					continuous ⁽⁴⁾
Write Status Register	01h	S7-S0					
Page Program	02h	A23-A16	A15-A8	A7-A0	D7-D0	Next byte	continuous
Quad Input Page Program	32h	A23-A16	A15-A8	A7-A0	(D7-D0,) ⁽⁵⁾		(one byte per 2 clocks, continuous)
Sector Erase	20h	A23-A16	A15-A8	A7-A0			
32KB Half Block Erase (HBE)	52h	A23-A16	A15-A8	A7-A0			
64KB Block Erase	D8h	A23-A16	A15-A8	A7-A0			
Chip Erase	C7h/ 60h						
Deep Power-down	B9h						
Release from Deep Power-down, and read Device ID	ABh	dummy	dummy	dummy	(ID7-ID0)		(6)
Release from Deep Power-down							
Manufacturer/	90h	dummy	dummy	00h	(M7-M0)	(ID7-ID0)	(7)
Device ID		dummy	dummy	01h	(ID7-ID0)	(M7-M0)	
Read Identification	9Fh	(M7-M0)	(ID15-ID8)	(ID7-ID0)	(8)		
Enter OTP mode	3Ah						
Read SFDP mode and Unique ID Number	5Ah	A23-A16	A15-A8	A7-A0	dummy	(D7-D0)	(Next Byte) continuous

Notes:

1. Device accepts eight-clocks command in Standard SPI mode, or two-clocks command in Quad SPI mode

2. RST command only executed if RSTEN command is executed first. Any intervening command will disable Reset.

3. Data bytes are shifted with Most Significant Bit first. Byte fields with data in parenthesis "()" indicate data being read from the device on the DO pin

4. The Status Register contents will repeat continuously until CS# terminate the instruction

5. Quad Data

 $\begin{array}{l} \mathsf{DQ}_0 = (\mathsf{D4},\,\mathsf{D0},\,\ldots\ldots) \\ \mathsf{DQ}_1 = (\mathsf{D5},\,\mathsf{D1},\,\ldots\ldots) \\ \mathsf{DQ}_2 = (\mathsf{D6},\,\mathsf{D2},\,\ldots\ldots) \\ \mathsf{DQ}_3 = (\mathsf{D7},\,\mathsf{D3},\,\ldots\ldots) \end{array}$

6. The Device ID will repeat continuously until CS# terminates the instruction

7. The Manufacturer ID and Device ID bytes will repeat continuously until CS# terminates the instruction.

00h on Byte 4 starts with MID and alternate with DID, 01h on Byte 4 starts with DID and alternate with MID 8. (M7-M0): Manufacturer, (ID15-ID8) : Memory Type, (ID7-ID0) : Memory Capacity



Table 6B. Instruction Set (Read Instruction)

Instruction Name	OP Code	Address bits	Dummy bits / Clocks (Default)	Data Out	Remark
Read Data	03h	24 bits	0	(D7-D0,)	(Next Byte) continuous
Fast Read	0Bh	24 bits	8 bits / 8 clocks	(D7-D0,)	(Next Byte) continuous
Dual Output Fast Read	3Bh	24 bits	8 bits / 8 clocks	(D7-D0,)	(one byte Per 4 clocks, continuous)
Dual I/O Fast Read	BBh	24 bits	8 bits / 4 clocks	(D7-D0,)	(one byte Per 4 clocks, continuous)
Quad I/O Fast Read	EBh	24 bits	24 bits / 6 clocks	(D7-D0,)	(one byte per 2 clocks, continuous)
Quad Output Fast Read	6Bh	24 bits	8 bits / 8 clocks	(D7-D0,)	(one byte per 2 clocks, continuous)

Table 6C. Instruction Set (Read Instruction support mode and dummy cycle setting)

Instruction Name	OP Code	Start Fror	n SPI/QPI	Dummy Cycle		
instruction name	OP Code	SPI	QPI	SPI	QPI	
Read Data	03h	Yes	No	N/A	N/A	
Fast Read	0Bh	Yes	Yes	8 clocks	6 clocks	
Dual Output Fast Read	3Bh	Yes	No	8 clocks	N/A	
Dual I/O Fast Read	BBh	Yes	No	4 clocks	N/A	
Quad I/O Fast Read	EBh	Yes	Yes	6 clocks	6 clocks	
Quad Input/Output Fast Read Enhance Performance Mode	EBh	Yes	Yes	6 clocks (2 clocks are performance enhance indicator)	6 clocks (2 clocks are performance enhance indicator)	
Quad Output Fast Read	6Bh	Yes	No	8 clocks	N/A	

Note:

1. 'Start From SPI/QPI' means if this command is initiated from SPI or QPI mode.

Table 7. Manufacturer and Device Identification

OP Code	(M7-M0)	(ID15-ID0)	(ID7-ID0)
ABh			11h
90h	1Ch		11h
9Fh	1Ch	3112h	



Enable Quad Peripheral Interface mode (EQPI) (38h)

The Enable Quad Peripheral Interface mode (EQPI) instruction will enable the flash device for Quad SPI bus operation. Upon completion of the instruction, all instructions thereafter will be 4-bit multiplexed input/output until a power cycle or "Reset Quad I/O instruction" instruction, as shown in Figure 6. The device did not support the Read Data Bytes (READ) (03h), Dual Output Fast Read (3Bh) and Dual Input/Output FAST_READ (BBh) and Quad Input Page Program (32h) modes while the Enable Quad Peripheral Interface mode (EQPI) (38h) turns on.

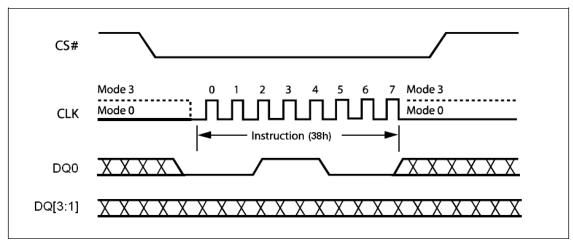


Figure 6. Enable Quad Peripheral Interface mode Sequence Diagram

Reset Quad I/O (RSTQIO) or Release Quad I/O Fast Read Enhancement Mode (FFh)

The Reset Quad I/O instruction resets the device to 1-bit Standard SPI operation. To execute a Reset Quad I/O operation, the host drives CS# low, sends the Reset Quad I/O command cycle (FFh) then, drives CS# high. This command can't be used in Standard SPI mode.

User also can use the 0xFFh command to release the Quad I/O Fast Read Enhancement Mode. The detail description, please see the Quad I/O Fast Read Enhancement Mode section.

Note:

If the system is in the Quad I/O Fast Read Enhance Mode in QPI Mode, it is necessary to execute 0xFFh command by two times. The first 0xFFh command is to release Quad I/O Fast Read Enhance Mode, and the second 0xFFh command is to release QPI Mode.



Reset-Enable (RSTEN) (66h) and Reset (RST) (99h)

The Reset operation is used as a system (software) reset that puts the device in normal operating Ready mode. This operation consists of two commands: Reset-Enable (RSTEN) and Reset (RST).

To reset the device the host drives CS# low, sends the Reset-Enable command (66h), and drives CS# high. Next, the host drives CS# low again, sends the Reset command (99h), and drives CS# high.

The Reset operation requires the Reset-Enable command followed by the Reset command. Any command other than the Reset command after the Reset-Enable command will disable the Reset-Enable.

A successful command execution will reset the Status register to data = 00h, see Figure 7 for SPI Mode and Figure 7.1 for QPI Mode. A device reset during an active Program or Erase operation aborts the operation, which can cause the data of the targeted address range to be corrupted or lost. Depending on the prior operation, the reset timing may vary. Recovery from a Write operation requires more software latency time (t_{SR}) than recovery from other operations. Please Figure 7.2.

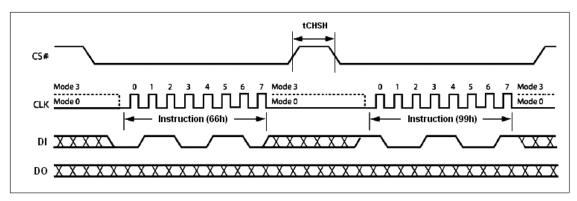


Figure 7. Reset-Enable and Reset Sequence Diagram

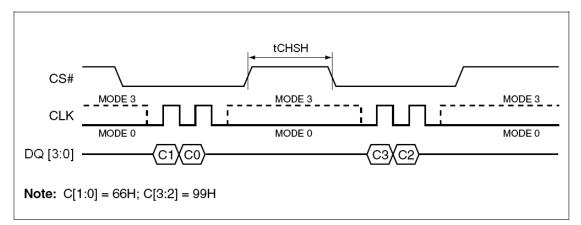


Figure 7.1 Reset-Enable and Reset Sequence Diagram in QPI Mode

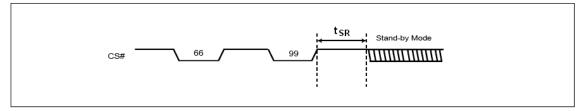
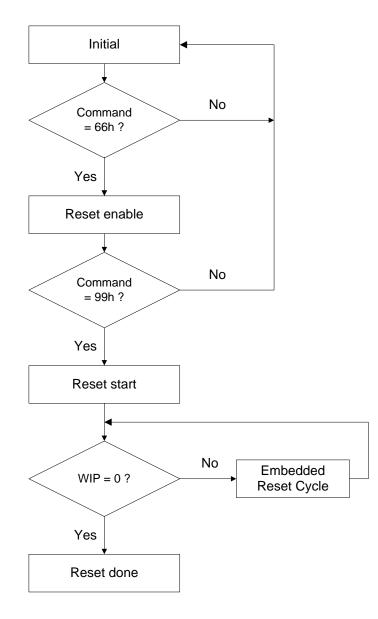


Figure 7.2 Software Reset Recovery

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Software Reset Flow



Note:

- 1. Reset-Enable (RSTEN) (66h) and Reset (RST) (99h) commands need to match standard SPI or QPI (Full Quad) mode.
- 2. Continue (Enhance) EB mode need to use quad Reset-Enable (RSTEN) (66h) and quad Reset (RST) (99h) commands.
- If user is not sure it is in SPI or Quad mode, we suggest to execute sequence as follows: Quad Reset-Enable (RSTEN) (66h) -> Quad Reset (RST) (99h) -> SPI Reset-Enable (RSTEN) (66h) -> SPI Reset (RST) (99h) to reset.
- 4. The reset command could be executed during embedded program and erase process, QPI mode and Continue EB mode to back to SPI mode.
- 5. This flow cannot release the device from Deep power down mode.
- 6. The Status Register Bit will reset to default value after reset done.
- 7. If user reset device during erase, the embedded reset cycle software reset latency will take about 28us in worst case.
- 8. User can't do software reset command while doing 4K/32K erase operation.



Write Enable (WREN) (06h)

The Write Enable (WREN) instruction (Figure 8) sets the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to every Page Program (PP), Sector Erase (SE), Half Block Erase (HBE), Block Erase (BE), Chip Erase (CE) and Write Status Register (WRSR) instruction.

The Write Enable (WREN) instruction is entered by driving Chip Select (CS#) Low, sending the instruction code, and then driving Chip Select (CS#) High.

The instruction sequence is shown in Figure 9.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

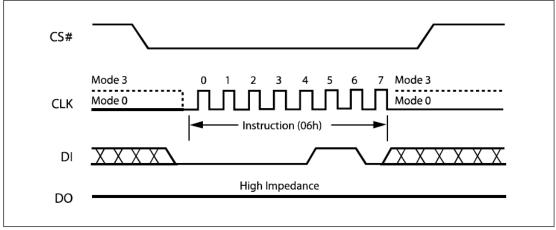


Figure 8. Write Enable Instruction Sequence Diagram

Write Disable (WRDI) (04h)

The Write Disable instruction (Figure 9) resets the Write Enable Latch (WEL) bit in the Status Register to a 0 or exit from OTP mode to normal mode. The Write Disable instruction is entered by driving Chip Select (CS#) low, shifting the instruction code "04h" into the DI pin and then driving Chip Select (CS#) high. Note that the WEL bit is automatically reset after Power-up and upon completion of the Write Status Register, Page Program, Sector Erase, Half Block Erase (HBE), Block Erase (BE) and Chip Erase instructions.

The instruction sequence is shown in Figure 9.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

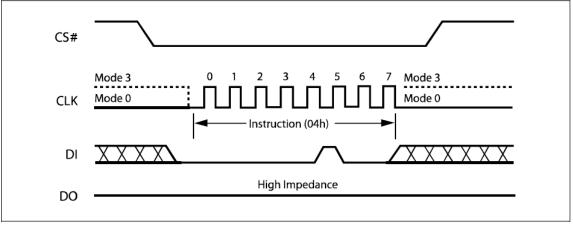


Figure 9. Write Disable Instruction Sequence Diagram



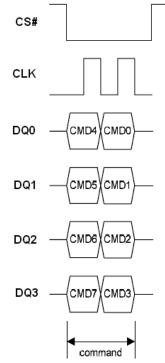


Figure 9.1 Write Enable/Disable Instruction Sequence in QPI Mode



Read Status Register (RDSR) (05h)

The Read Status Register (RDSR) instruction allows the Status Register to be read. The Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write In Progress (WIP) bit before sending a new instruction to the device. It is also possible to read the Status Register continuously, as shown in Figure 10.

The instruction sequence is shown in Figure 10.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

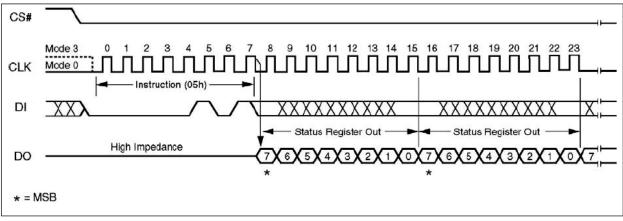
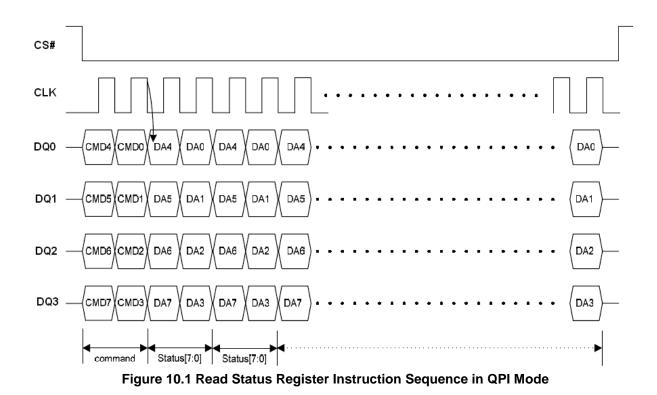


Figure 10. Read Status Register Instruction Sequence Diagram



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Table 8. Status Register Bit Locations

S7	S6	S5	S4	S3	S2	S1	S0
SRP bit	WHDIS bit	BP3 bit	BP2 bit	BP1 bit	BP0 bit	WEL bit	WIP bit
SPL0 bit	TB bit	Reversed	4KB BL bit (4KB boot lock)	EBL bit (Enable boot lock)	SPL1 bit	SPL2 bit	WIP bit

Table 8.1 Status Register Bit Locations (In Normal mode)

S7	S 6	S5	S4	S 3	S2	S1	S0
SRP Status Register Protect	WHDIS bit (WP# and Hold# disabled)	BP3 (Block Protected bits)	BP2 (Block Protected bits)	BP1 (Block Protected bits)	BP0 (Block Protected bits)	WEL bit (Write Enable Latch)	WIP bit (Write In Progress bit)
1 = status register write disable	1 = WP# and HOLD# disable 0 = WP# and HOLD# enable	(note 2)	(note 2)	(note 2)	(note 2)	1 = write enable 0 = not write enable	1 = write operation 0 = not in write operation
Non-volatile bit	Non-volatile bit	Non-volatile bit	Non-volatile bit	Non-volatile bit	Non-volatile bit	Read only bit	Read only bit

Table 8.2 Status Register Bit Locations (In OTP mode)

S 7	S6	S5	S4	S 3	S2	S1	S0
SPL0 bit	TB bit		4KB BL bit (4KB boot lock)	EBL bit (Enable boot lock)	SPL1 bit	SPL2 bit	WIP bit (Write In Progress bit)
1 = security sector 0 is protected	1 = Bottom 0 = Top (default 0)	Reversed	1 = Sector 0 = 64KB Block (default 0)	1 = Permanent lock selected 64KB- Block/Sector	1 = security sector 1 is protected	1 = security sector 2 is protected	1 = write operation 0 = not in write operation
OTP bit	OTP bit		OTP bit	OTP bit	OTP bit	OTP bit	Read only bit

Note:

1. In OTP mode, S7 bit is served as SPL0 bit; S6 bit is served as TB bit; S4 bit is served as 4KB BL bit; S3 bit is served as EBL bit; S2 bit is served as SPL1 bit; S1 bit is served as SPL2 bit and S0 bit is served as WIP bit.

2. See the table 4 "Protected Area Sizes Sector Organization".

The status and control bits of the Status Register are as follows:

WIP bit. The Write In Progress (WIP) bit indicates whether the memory is busy with a Write Status Register, Program or Erase cycle. When set to 1, such a cycle is in progress, when reset to 0 no such cycle is in progress.

WEL bit. The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write Status Register, Program or Erase instruction is accepted.



BP3, BP2, BP1, BP0 bits. The Block Protect (BP3, BP2, BP1, BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase instructions. These bits are written with the Write Status Register (WRSR) instruction. When one or both of the Block Protect (BP3, BP2, BP1, BP0) bits is set to 1, the relevant memory area (as defined in Table 4.) becomes protected against Page Program (PP) Sector Erase (SE) and , Block Erase (BE), instructions. The Block Protect (BP3, BP2, BP1, BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) instruction is executed if, and only if, all Block Protect (BP3, BP2, BP1, BP0) bits are 0.

WHDIS bit. The WP# and Hold# Disable bit (WHDIS bit), non-volatile bit, it indicates the WP# and HOLD# are enabled or not. When it is "0" (factory default), the WP# and HOLD# are enabled. On the other hand, while WHDIS bit is "1", the WP# and HOLD# are disabled. No matter WHDIS is "0" or "1", the system can executes Quad Input/Output FAST_READ (EBh) or EQPI (38h) command directly. User can use Flash Programmer to set WHDIS bit as "1" and then the host system can let WP# and HOLD# keep floating in SPI mode.

SRP bit. The Status Register Protect (SRP) bit is operated in conjunction with the Write Protect (WP#) signal. The Status Register Write Protect (SRP) bit and Write Protect (WP#) signal allow the device to be put in the Hardware Protected mode (when the Status Register Protect (SRP) bit is set to 1, and Write Protect (WP#) is driven Low). In this mode, the non-volatile bits of the Status Register (SRP, BP3, BP2, BP1, BP0) become read-only bits and the Write Status Register (WRSR) instruction is no longer accepted for execution.

In OTP mode, S7, S6, S4, S3, S2, S1 and S0 are served as SPL0 Bit, TB bit, 4KB BL bit, EBL bit, SPL1 bit, SPL2 bit and WIP bit.

SPL2 bit. (S1)

The SPL2 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 2. User can read/program/erase security sector 2 as normal sector while SPL2 value is equal 0, after SPL2 is programmed with 1 by WRSR command, the security sector 2 is protected from program and erase operation. The SPL2 bit can only be programmed once.

SPL1 bit. (S2)

The SPL1 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 1. User can read/program/erase security sector 1 as normal sector while SPL1 value is equal 0, after SPL1 is programmed with 1 by WRSR command, the security sector 1 is protected from program and erase operation. The SPL1 bit can only be programmed once.

Enable Boot Lock bit. (S3)

When this bit is programmed to '1' by WRSR command in OTP mode, the Top/Bottom switch bit and 64KB-Block/Sector switch bit and the selected sector/block will be permanent locked. The Enable Boot Lock bit can only be programmed once.

64KB-Block/Sector switch bit. (S4)

This bit is set by WRSR command in OTP mode. It is used to set the protection area size as block (64KB) or sector (4KB).

Top/Bottom switch bit. (S6)

This bit is set by WRSR command in OTP mode. It is used to set the protected 64KB-Block/Sector location to the top/bottom in the device.

SPL0 bit. (S7)

The SPL0 bit is non-volatile One Time Program (OTP) bit in status register that provide the write protect control and status to the security sector 0. User can read/program/erase security sector 0 as normal sector while SPL0 value is equal 0, after SPL0 is programmed with 1 by WRSR command, the security sector 0 is protected from program and erase operation. The SPL0 bit can only be programmed once.



Write Status Register (WRSR) (01h)

The Write Status Register (WRSR) instruction allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code and the data byte on Serial Data Input (DI).

The instruction sequence is shown in Figure 11. The Write Status Register (WRSR) instruction has no effect on S1 and S0 of the Status Register. Chip Select (CS#) must be driven High after the eighth bit of the data byte has been latched in. If not, the Write Status Register (WRSR) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Write Status Register cycle (whose duration is t_W) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) instruction allows the user to change the values of the Block Protect (BP3, BP2, BP1, BP0) bits, to define the size of the area that is to be treated as read-only, as defined in Table 4. The Write Status Register (WRSR) instruction also allows the user to set or reset the Status Register Protect (SRP) bit in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP) bit and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode (HPM). The Write Status Register (WRSR) instruction is not executed once the Hardware Protected Mode (HPM) is entered.

The instruction sequence is shown in Figure 11.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

NOTE:

In the OTP mode, WRSR command is used to program SPL0 bit, SPL1 bit, SPL2 bit, TB bit, 4KB BL bit and EBL bit to '1', but these bits can only be programmed once.

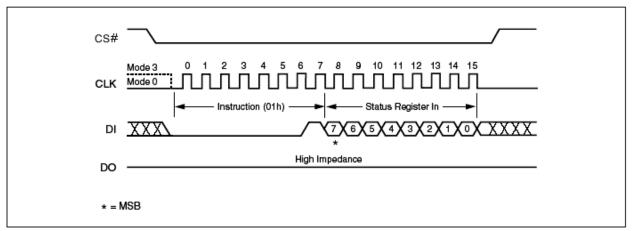


Figure 11. Write Status Register Instruction Sequence Diagram



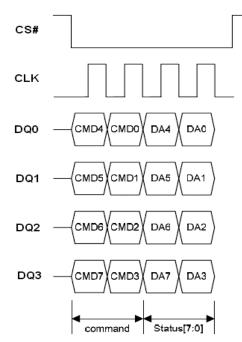


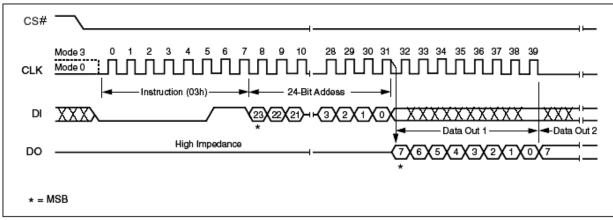
Figure 11.1 Write Status Register Instruction Sequence in QPI Mode

Read Data Bytes (READ) (03h)

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read Data Bytes (READ) instruction is followed by a 3-byte address (A23-A0), each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency f_R , during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Figure 12. The first byte addresses can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes (READ) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes (READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.







Read Data Bytes at Higher Speed (FAST_READ) (0Bh)

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read Data Bytes at Higher Speed (FAST_READ) instruction is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency F_R , during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Figure 13. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes at Higher Speed (FAST_READ) instruction. When the highest address is reached, the address counter rolls over to 000000h, allowing the read sequence to be continued indefinitely.

The Read Data Bytes at Higher Speed (FAST_READ) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes at Higher Speed (FAST_READ) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

The instruction sequence is shown in Figure 13.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

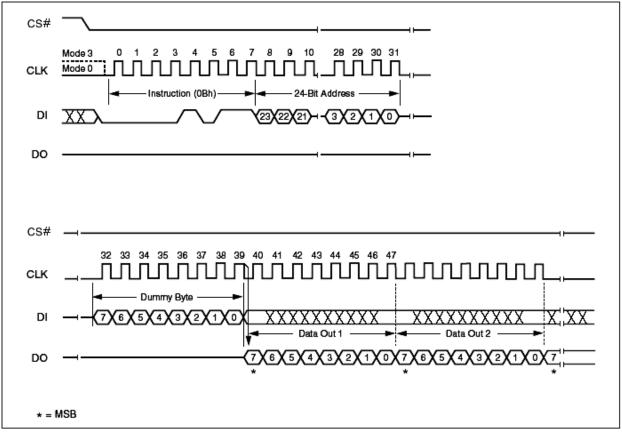
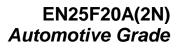


Figure 13. Fast Read Instruction Sequence Diagram

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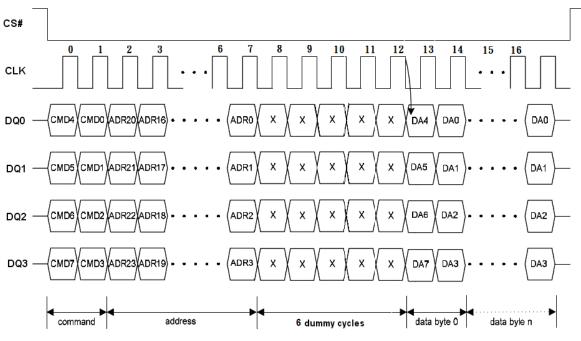


Figure 13.1 Fast Read Instruction Sequence in QPI Mode



Dual Output Fast Read (3Bh)

The Dual Output Fast Read (3Bh) is similar to the standard Fast Read (0Bh) instruction except that data is output on two pins, DQ_0 and DQ_1 , instead of just DQ_0 . This allows data to be transferred from the device at twice the rate of standard SPI devices. The Dual Output Fast Read instruction is ideal for quickly downloading code from to RAM upon power-up or for applications that cache code-segments to RAM for execution.

Similar to the Fast Read instruction, the Dual Output Fast Read instruction can operation at the highest possible frequency of F_R (see AC Electrical Characteristics). This is accomplished by adding eight "dummy clocks after the 24-bit address as shown in Figure 14. The dummy clocks allow the device's internal circuits additional time for setting up the initial address. The input data during the dummy clock is "don't care". However, the DI pin should be high-impedance prior to the falling edge of the first data out clock.

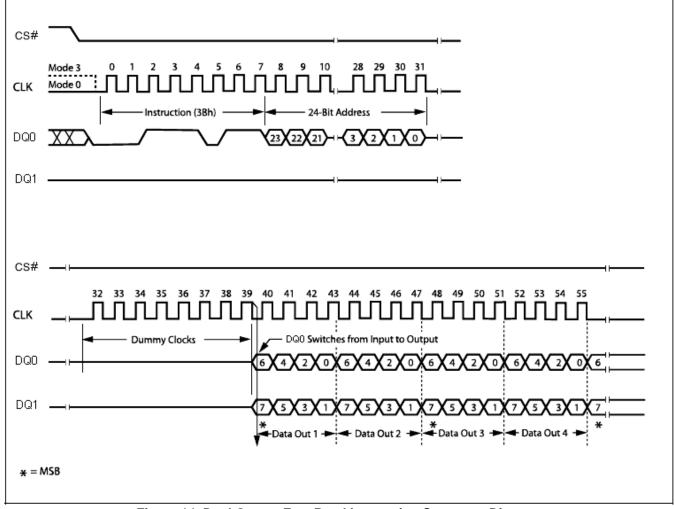


Figure 14. Dual Output Fast Read Instruction Sequence Diagram



Dual Input / Output FAST_READ (BBh)

The Dual I/O Fast Read (BBh) instruction allows for improved random access while maintaining two IO pins, DQ_0 and DQ_1 . It is similar to the Dual Output Fast Read (3Bh) instruction but with the capability to input the Address bits (A23-A0) two bits per clock. This reduced instruction overhead may allow for code execution (XIP) directly from the Dual SPI in some applications.

The Dual I/O Fast Read instruction enable double throughput of Serial Flash in read mode. The address is latched on rising edge of CLK, and data of every two bits (interleave 2 I/O pins) shift out on the falling edge of CLK at a maximum frequency. The first address can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Dual I/O Fast Read instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing Dual I/O Fast Read instruction, the following address/dummy/data out will perform as 2-bit instead of previous 1-bit, as shown in Figure 15.

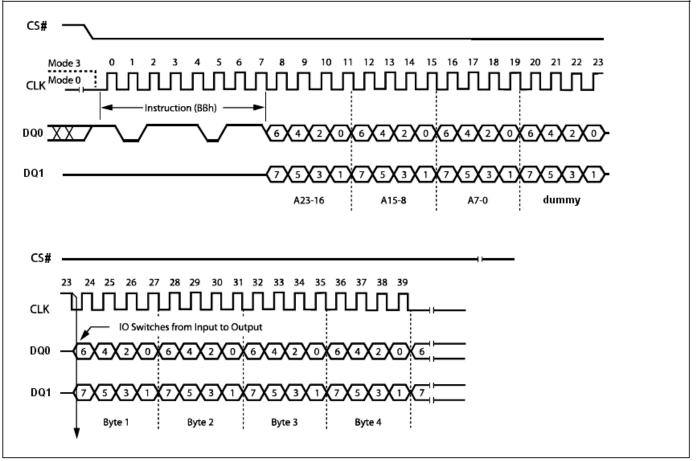


Figure 15. Dual Input / Output Fast Read Instruction Sequence Diagram



Quad Output Fast Read (6Bh)

The Quad Output Fast Read (6Bh) instruction is similar to the Dual Output Fast Read (3Bh) instruction except that data is output through four pins, DQ_0 , DQ_1 , DQ_2 and DQ_3 and eight dummy clocks are required prior to the data output. The Quad Output dramatically reduces instruction overhead allowing faster random access for code execution (XIP) directly from the Quad SPI.

The Quad Output Fast Read (6Bh) address is latching on rising edge of CLK, and data of every four bits (interleave on 4 I/O pins) shift out on the falling edge of CLK at a maximum frequency F_R . The first address can be any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Quad Output Fast Read instruction. The address counter rolls over to 0 when the highest address has been reached.

The sequence of issuing Quad Output Fast Read (6Bh) instruction is: CS# goes low -> sending Quad Output Fast Read (6Bh) instruction -> 24-bit address on DQ_0 -> 8 dummy clocks -> data out interleave on DQ_3 , DQ_2 , DQ_1 and DQ_0 -> to end Quad Output Fast Read (6Bh) operation can use CS# to high at any time during data out, as shown in Figure 16. The WP# (DQ2) and HOLD# (DQ3) need to drive high before address input if WHDIS bit in Status Register is 0.

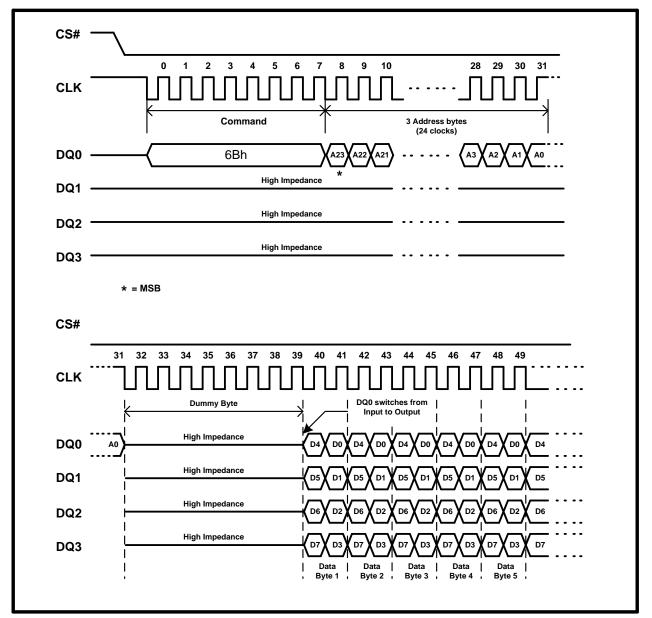


Figure 16. Quad Output Fast Read Instruction Sequence Diagram



Quad Input / Output FAST_READ (EBh)

The Quad Input/Output FAST_READ (EBh) instruction is similar to the Dual I/O Fast Read (BBh) instruction except that address and data bits are input and output through four pins, DQ_0 , DQ_1 , DQ_2 and DQ_3 and six dummy clocks are required prior to the data output. The Quad I/O dramatically reduces instruction overhead allowing faster random access for code execution (XIP) directly from the Quad SPI.

The Quad Input/Output FAST_READ (EBh) instruction enable quad throughput of Serial Flash in read mode. The address is latching on rising edge of CLK, and data of every four bits (interleave on 4 I/O pins) shift our on the falling edge of CLK at a maximum frequency F_R . The first address can be any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out at a single Quad Input/Output FAST_READ instruction. The address counter rolls over to 0 when the highest address has been reached. Once writing Quad Input/Output FAST_READ instruction, the following address/dummy/data out will perform as 4-bit instead of previous 1-bit.

The sequence of issuing Quad Input/Output FAST_READ (EBh) instruction is: CS# goes low -> sending Quad Input/Output FAST_READ (EBh) instruction -> 24-bit address interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> 6 dummy cycles -> data out interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> 6 dummy cycles -> data out interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> to end Quad Input/Output FAST_READ (EBh) operation can use CS# to high at any time during data out, as shown in Figure 17.

The instruction sequence is shown in Figure 17.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

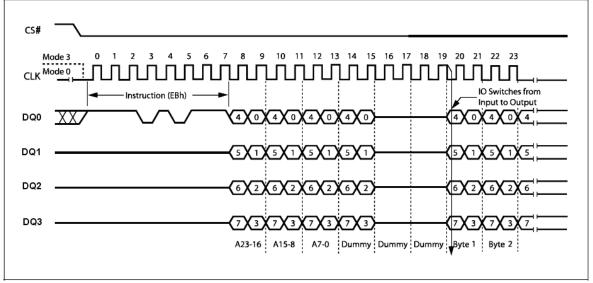


Figure 17. Quad Input / Output Fast Read Instruction Sequence Diagram



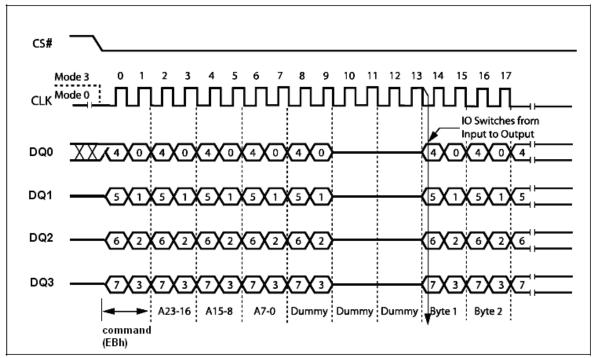


Figure 17.1. Quad Input / Output Fast Read Instruction Sequence in QPI Mode

Another sequence of issuing Quad Input/Output FAST_READ (EBh) instruction especially useful in random access is : CS# goes low -> sending Quad Input/Output FAST_READ (EBh) instruction -> 24-bit address interleave on DQ₃, DQ₂, DQ₁ and DQ₀ -> performance enhance toggling bit P[7:0] -> 4 dummy cycles -> data out interleave on DQ₃, DQ₂, DQ₁ and DQ₀ till CS# goes high -> CS# goes low (reduce Quad Input/Output FAST_READ (EBh) instruction) -> 24-bit access address, as shown in Figure 18.

In the performance – enhancing mode, P[7:4] must be toggling with P[3:0]; likewise P[7:0] = A5h, 5Ah, F0h or 0Fh can make this mode continue and reduce the next Quad Input/Output FAST_READ (EBh) instruction. Once P[7:4] is no longer toggling with P[3:0]; likewise P[7:0] = FFh, 00h, AAh or 55h. And afterwards CS# is raised, the system then will escape from performance enhance mode and return to normal operation.

While Program/ Erase/ Write Status Register is in progress, Quad Input/Output FAST_READ (EBh) instruction is rejected without impact on the Program/ Erase/ Write Status Register current cycle.

The instruction sequence is shown in Figure 18.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.



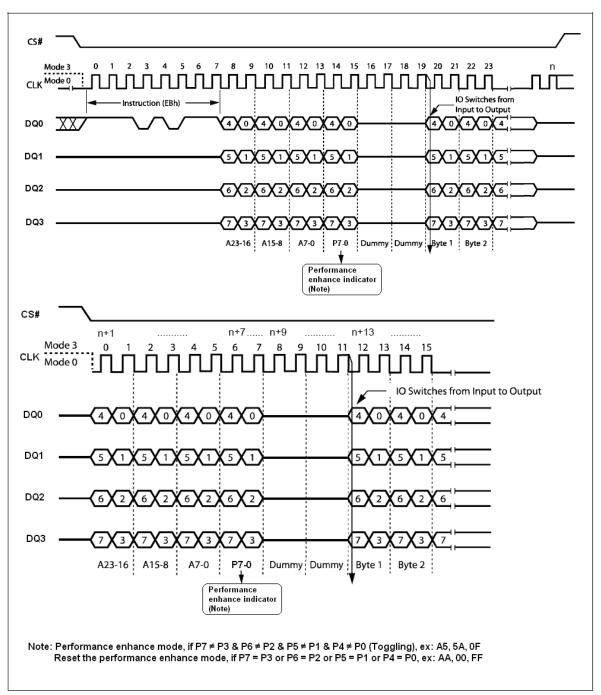


Figure 18. Quad Input/Output Fast Read Enhance Performance Mode Sequence Diagram



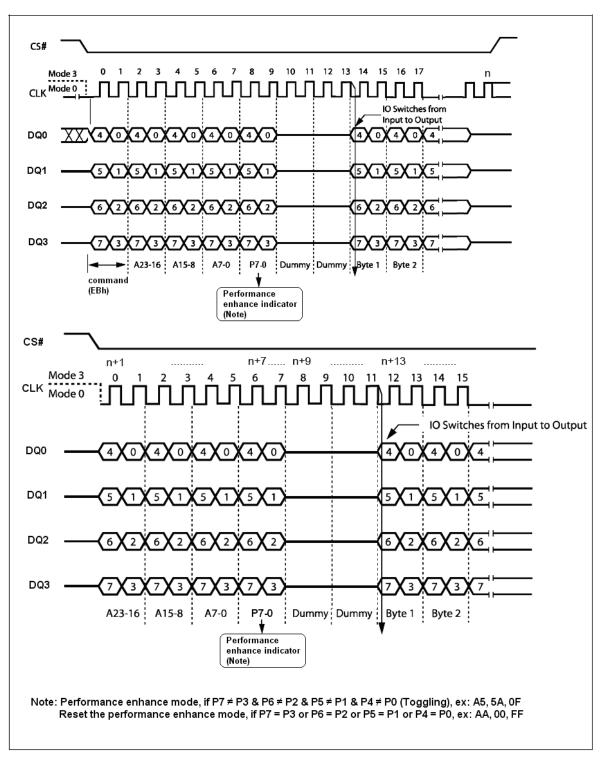


Figure 18.1 Quad Input/Output Fast Read Enhance Performance Mode Sequence in QPI Mode



Page Program (PP) (02h)

The Page Program (PP) instruction allows bytes to be programmed in the memory. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Page Program (PP) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, three address bytes and at least one data byte on Serial Data Input (DI). If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 8 least significant bits (A7-A0) are all zero). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 19. If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 Data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page.

Chip Select (CS#) must be driven High after the eighth bit of the last data byte has been latched in, otherwise the Page Program (PP) instruction is not executed.

As soon as Chip Select (CS#) is driven High, the self-timed Page Program cycle (whose duration is t_{PP}) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) instruction applied to a page which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Table 4) is not executed.

The instruction sequence is shown in Figure 19.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

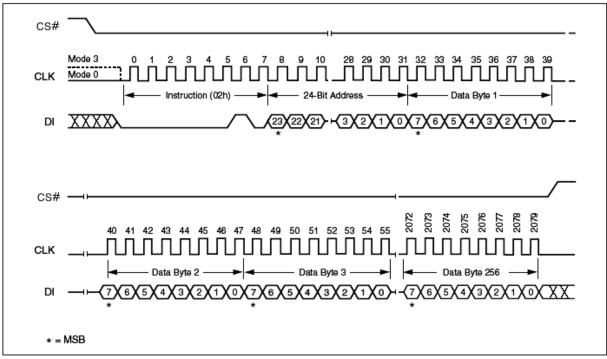


Figure 19. Page Program Instruction Sequence Diagram



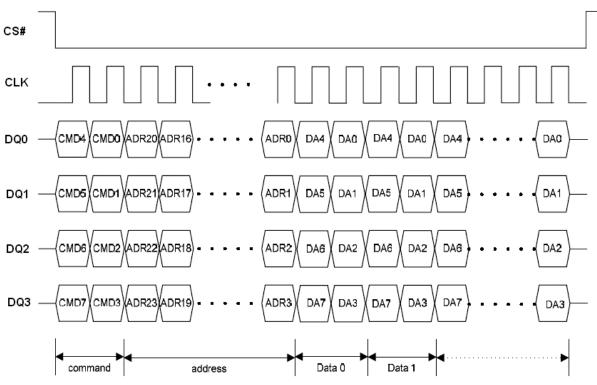


Figure 19.1 Program Instruction Sequence in QPI Mode



Quad Input Page Program (QPP) (32h)

The Quad Page Program (QPP) instruction allows up to 256 bytes of data to be programmed at previously erased (FFh) memory locations using four pins: DQ_0 , DQ_1 , DQ_2 and DQ_3 . The Quad Page Program can improve performance for PROM Programmer and applications that have slow clock speeds < 5MHz. Systems with faster clock speed will not realize much benefit for the Quad Page Program instruction since the inherent page program time is much greater than the time it take to clock-in the data.

To use Quad Page Program (QPP) the WP# & Hold# Disable (WHDIS) bit in Status Register must be set to 1. A Write Enable instruction must be executed before the device will accept the Quad Page Program (QPP) instruction (S1, WEL=1). The instruction is initiated by driving the CS# pin low then shifting the instruction code "32h" followed by a 24-bit address (A23-A0) and at least one data byte, into the IO pins. The CS# pin must be held low for the entire length of the instruction while data is being sent to the device. All other functions of Quad Page Program (QPP) are identical to standard Page Program. The Quad Page Program (QPP) instruction sequence is shown in Figure 20.

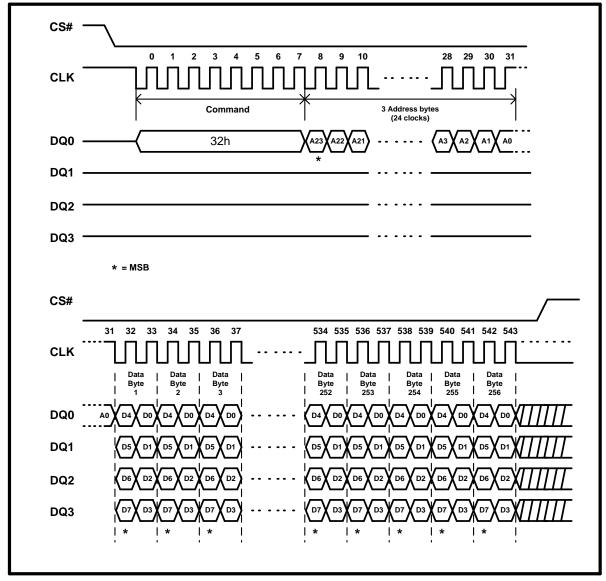


Figure 20. Quad Input Page Program Instruction Sequence Diagram (SPI Mode only)

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Sector Erase (SE) (20h)

The Sector Erase (SE) instruction sets to 1 (FFh) all bits inside the chosen sector. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Sector Erase (SE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Sector (see Table 3) is a valid address for the Sector Erase (SE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 21. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Sector Erase (SE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Sector Erase cycle (whose duration is t_{SE}) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Sector Erase (SE) instruction applied to a sector which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Table 4) is not executed.

The instruction sequence is shown in Figure 21.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

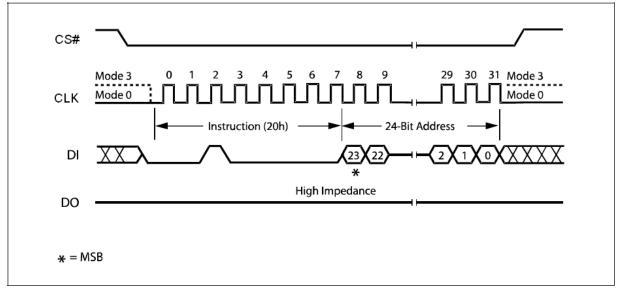


Figure 21. Sector Erase Instruction Sequence Diagram



32KB Half Block Erase (HBE) (52h)

The Half Block Erase (HBE) instruction sets to 1 (FFh) all bits inside the chosen block. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Half Block Erase (HBE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Block (see Table 3) is a valid address for the Half Block Erase (HBE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 22. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Half Block Erase (HBE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Half Block Erase cycle (whose duration is t_{HBE}) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Half Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Half Block Erase (HBE) instruction applied to a block which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Table 4) is not executed.

The instruction sequence is shown in Figure 22.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

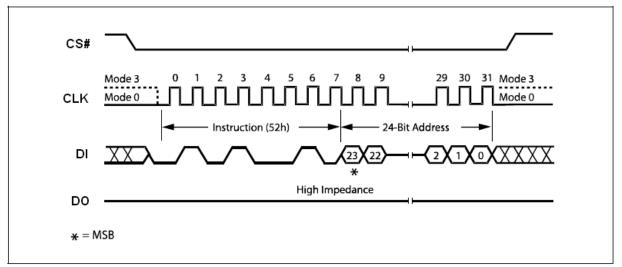


Figure 22. 32KB Half Block Erase Instruction Sequence Diagram



64KB Block Erase (BE) (D8h)

The Block Erase (BE) instruction sets to 1 (FFh) all bits inside the chosen block. Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Block Erase (BE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code, and three address bytes on Serial Data Input (DI). Any address inside the Block (see Table 3) is a valid address for the Block Erase (BE) instruction. Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 23. Chip Select (CS#) must be driven High after the eighth bit of the last address byte has been latched in, otherwise the Block Erase (BE) instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Block Erase cycle (whose duration is t_{BE}) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Block Erase (BE) instruction applied to a block which is protected by the Block Protect (BP3, BP2, BP1, BP0) bits (see Table 4) is not executed.

The instruction sequence is shown in Figure 23.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

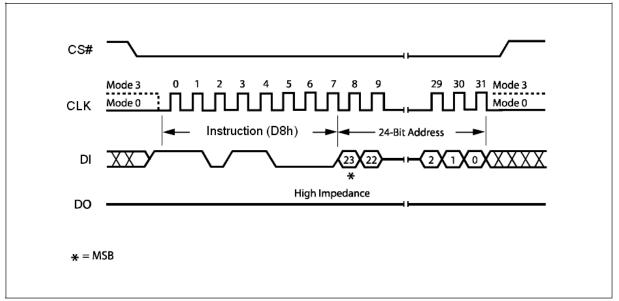


Figure 23. 64KB Block Erase Instruction Sequence Diagram



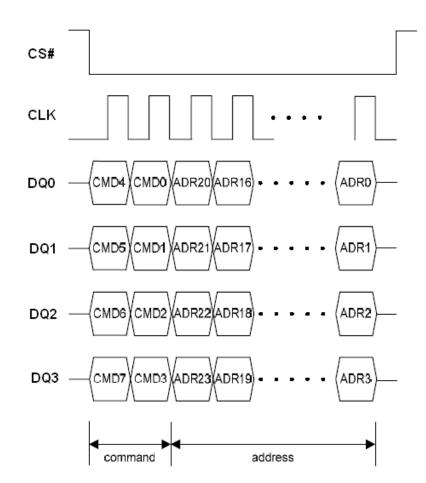


Figure 23.1 Half Block/Block/Sector Erase Instruction Sequence in QPI Mode



Chip Erase (CE) (C7h/60h)

The Chip Erase (CE) instruction sets all bits to 1 (FFh). Before it can be accepted, a Write Enable (WREN) instruction must previously have been executed. After the Write Enable (WREN) instruction has been decoded, the device sets the Write Enable Latch (WEL).

The Chip Erase (CE) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code on Serial Data Input (DI). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 24. Chip Select (CS#) must be driven High after the eighth bit of the instruction code has been latched in, otherwise the Chip Erase instruction is not executed. As soon as Chip Select (CS#) is driven High, the self-timed Chip Erase cycle (whose duration is t_{CE}) is initiated. While the Chip Erase cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Chip Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

The Chip Erase (CE) instruction is executed only if all Block Protect (BP3, BP2, BP1, BP0) bits are 0. The Chip Erase (CE) instruction is ignored if one, or more blocks are protected.

The instruction sequence is shown in Figure 24.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

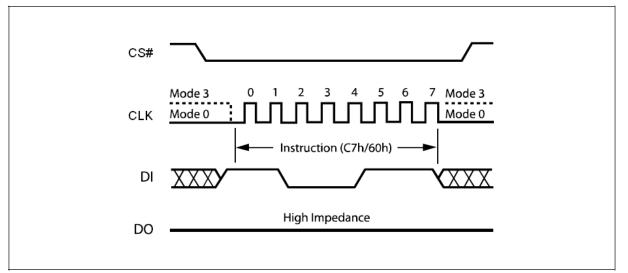


Figure 24. Chip Erase Instruction Sequence Diagram



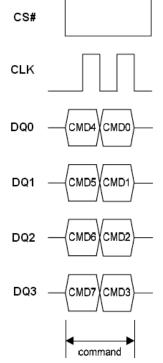


Figure 24.1 Chip Erase Sequence in QPI Mode

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Deep Power-down (DP) (B9h)

Executing the Deep Power-down (DP) instruction is the only way to put the device in the lowest consumption mode (the Deep Power-down mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase instructions.

Driving Chip Select (CS#) High deselects the device, and puts the device in the Standby mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-down mode. The Deep Power-down mode can only be entered by executing the Deep Power-down (DP) instruction, to reduce the standby current (from I_{CC1} to I_{CC2} , as specified in Table 14.)

Once the device has entered the Deep Power-down mode, all instructions are ignored except the Release from Deep Power-down and Read Device ID (RDI) instruction. This releases the device from this mode. The Release from Deep Power-down and Read Device ID (RDI) instruction also allows the Device ID of the device to be output on Serial Data Output (DO).

The Deep Power-down mode automatically stops at Power-down, and the device always Powers-up in the Standby mode. The Deep Power-down (DP) instruction is entered by driving Chip Select (CS#) Low, followed by the instruction code on Serial Data Input (DI). Chip Select (CS#) must be driven Low for the entire duration of the sequence.

The instruction sequence is shown in Figure 25. Chip Select (CS#) must be driven High after the eighth bit of the instruction code has been latched in, otherwise the Deep Power-down (DP) instruction is not executed. As soon as Chip Select (CS#) is driven High, it requires a delay of t_{DP} before the supply current is reduced to I_{CC2} and the Deep Power-down mode is entered.

Any Deep Power-down (DP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

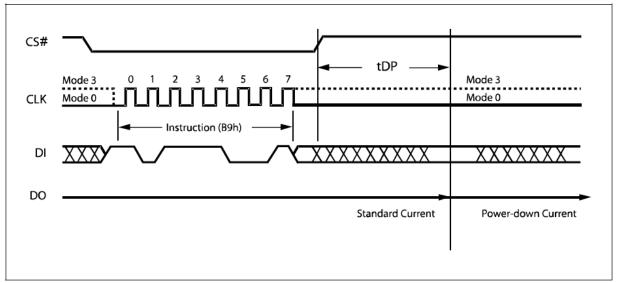


Figure 25. Deep Power-down Instruction Sequence Diagram



Release from Deep Power-down and Read Device ID (RDI)

Once the device has entered the Deep Power-down mode, all instructions are ignored except the Release from Deep Power-down and Read Device ID (RDI) instruction. Executing this instruction takes the device out of the Deep Power-down mode.

Please note that this is not the same as, or even a subset of, the JEDEC 16-bit Electronic Signature that is read by the Read Identifier (RDID) instruction. The old-style Electronic Signature is supported for reasons of backward compatibility, only, and should not be used for new designs. New designs should, instead, make use of the JEDEC 16-bit Electronic Signature, and the Read Identifier (RDID) instruction.

When used only to release the device from the power-down state, the instruction is issued by driving the CS# pin low, shifting the instruction code "ABh" and driving CS# high as shown in Figure 26. After the time duration of t_{RES1} (See AC Characteristics) the device will resume normal operation and other instructions will be accepted. The CS# pin must remain high during the t_{RES1} time duration.

When used only to obtain the Device ID while not in the power-down state, the instruction is initiated by driving the CS# pin low and shifting the instruction code "ABh" followed by 3-dummy bytes. The Device ID bits are then shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 27. The Device ID value for the device are listed in Table 7. The Device ID can be read continuously. The instruction is completed by driving CS# high.

When Chip Select (CS#) is driven High, the device is put in the Stand-by Power mode. If the device was not previously in the Deep Power-down mode, the transition to the Stand-by Power mode is immediate. If the device was previously in the Deep Power-down mode, though, the transition to the Standby Power mode is delayed by t_{RES2} , and Chip Select (CS#) must remain High for at least t_{RES2} (max), as specified in Table 16. Once in the Stand-by Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

Except while an Erase, Program or Write Status Register cycle is in progress, the Release from Deep Power-down and Read Device ID (RDI) instruction always provides access to the 8bit Device ID of the device, and can be applied even if the Deep Power-down mode has not been entered.

Any Release from Deep Power-down and Read Device ID (RDI) instruction while an Erase, Program or Write Status Register cycle is in progress, is not decoded, and has no effect on the cycle that is in progress.

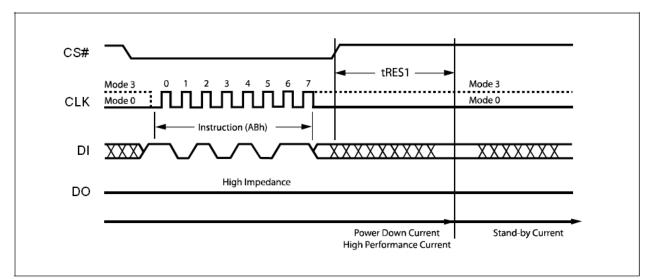


Figure 26. Release Power-down Instruction Sequence Diagram



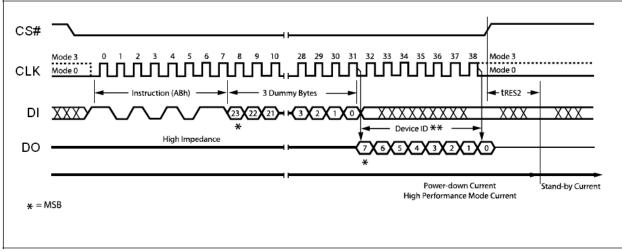


Figure 27. Release Power-down / Device ID Instruction Sequence Diagram

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Read Manufacturer / Device ID (90h)

The Read Manufacturer/Device ID instruction is an alternative to the Release from Power-down / Device ID instruction that provides both the JEDEC assigned manufacturer ID and the specific device ID.

The Read Manufacturer/Device ID instruction is very similar to the Release from Power-down / Device ID instruction. The instruction is initiated by driving the CS# pin low and shifting the instruction code "90h" followed by a 24-bit address of 000000h. After which, the Manufacturer ID for Eon (1Ch) and the Device ID are shifted out on the falling edge of CLK with most significant bit (MSB) first as shown in Figure 28. The Device ID values for the device are listed in Table 7. If the 24-bit address is initially set to 000001h the Device ID will be read first

The instruction sequence is shown in Figure 28.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

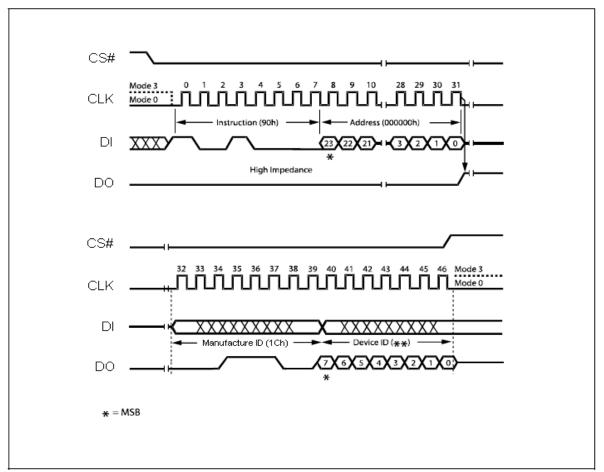


Figure 28. Read Manufacturer / Device ID Diagram



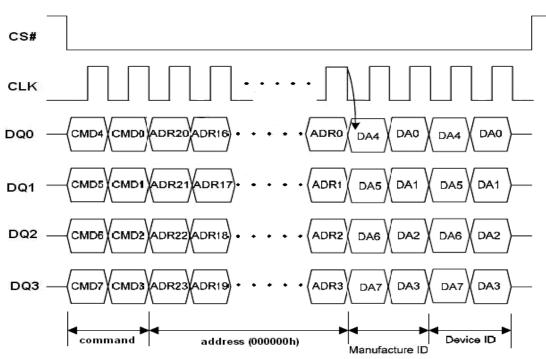


Figure 28.1 Read Manufacturer / Device ID Diagram in QPI Mode

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Read Identification (RDID) (9Fh)

The Read Identification (RDID) instruction allows the 8-bit manufacturer identification to be read, followed by two bytes of device identification. The device identification indicates the memory type in the first byte, and the memory capacity of the device in the second byte.

Any Read Identification (RDID) instruction while an Erase or Program cycle is in progress, is not decoded, and has no effect on the cycle that is in progress. The Read Identification (RDID) instruction should not be issued while the device is in Deep Power down mode.

The device is first selected by driving Chip Select Low. Then, the 8-bit instruction code for the instruction is shifted in. This is followed by the 24-bit device identification, stored in the memory, being shifted out on Serial Data Output, each bit being shifted out during the falling edge of Serial Clock. The instruction sequence is shown in Figure 29. The Read Identification (RDID) instruction is terminated by driving Chip Select High at any time during data output.

When Chip Select is driven High, the device is put in the Standby Power mode. Once in the Standby Power mode, the device waits to be selected, so that it can receive, decode and execute instructions.

The instruction sequence is shown in Figure 29.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

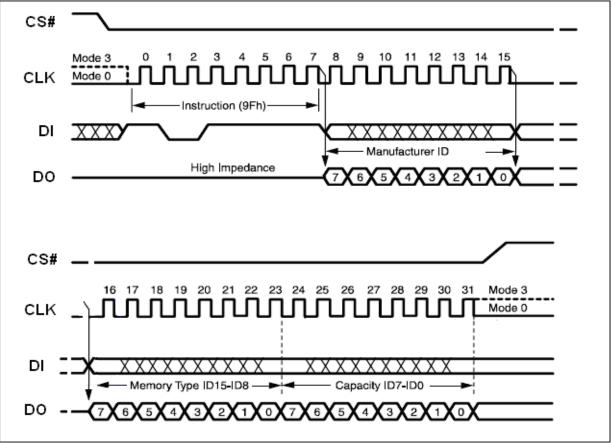
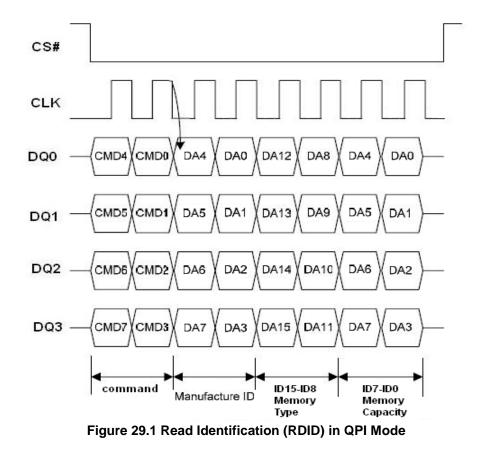


Figure 29. Read Identification (RDID)

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Enter OTP Mode (3Ah)

This Flash support OTP mode to enhance the data protection, user can use the Enter OTP mode (3Ah) command for entering this mode. In OTP mode, the Status Register S7 bit is served as SPL0 bit; S6 bit is served as TB bit; S4 bit is served as 4KB BL bit; S3 bit is served as EBL bit; S2 bit is served as SPL1 bit, S1 bit is served as SPL2 bit and S0 bit is served as WIP bit. They can be read by RDSR command.

This Flash has extra 3 OTP lockable security sectors, each security sector size is 512bytes, user must issue ENTER OTP MODE command to read, program or erase OTP sectors. After entering OTP mode, the OTP lockable security sectors are mapping to sector 63, 62, and 48, **SRP bit** becomes SPL0 bit, BP0 bit becomes SPL1 bit, WEL bit becomes SPL2 bit. The Chip Erase, Block Erase and Half Block Erase commands are also disabled.

The security sectors can **only** be erased by Sector Erase (20h) command. The Chip Erase (C7h/60h), 64k Block Erase (D8h) and 32K Half Block Erase (52h) commands are disable in OTP mode.

Table 9. OTP Sector Address

Sector	Sector Size	Address Range
63	512 byte	3F000h – 3F1FFh
62	512 byte	3E000h – 3E1FFh
48	512 byte	30000h – 301FFh

Note:

1. The OTP lockable security sectors are mapping to sector 63, sector 62, and sector 48.

2. While user wants to read data in SA48, SA62 and SA63, please exit OTP mode first.

3. While user want to erase one of security sector, only needs to do 1 time of Sector Erase instruction(20h).

The Enable Boot Lock feature is configured in OTP mode. It enables user to lock the 64KB-Block/Sector on the top/bottom of the device for protection. This feature is activated by programming the EBL bit to '1'. WRSR command is used to program SPL0 bit, TB bit, 4KB BK bit, EBL bit, SPL1 bit, and SPL2 bit to '1', but these bits only can be programmed once. User can use WRDI (04h) command to exit OTP mode.

The instruction sequence is shown in Figure 30.1 while using the Enable Quad Peripheral Interface mode (EQPI) (38h) command.

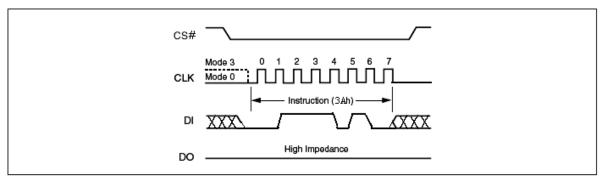
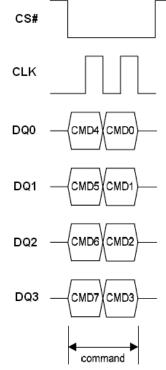


Figure 30. Enter OTP Mode Sequence





Figue 30.1 Enter OTP Mode Sequence in QPI Mode

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Read SFDP Mode and Unique ID Number (5Ah)

Read SFDP Mode

Device features Serial Flash Discoverable Parameters (SFDP) mode. Host system can retrieve the operating characteristics, structure and vendor specified information such as identifying information, memory size, operating voltage and timing information of this device by SFDP mode.

The device is first selected by driving Chip Select (CS#) Low. The instruction code for the Read SFDP Mode is followed by a 3-byte address (A23-A0) and a dummy byte, each bit being latched-in during the rising edge of Serial Clock (CLK). Then the memory contents, at that address, is shifted out on Serial Data Output (DO), each bit being shifted out, at a maximum frequency FR, during the falling edge of Serial Clock (CLK).

The instruction sequence is shown in Figure 31. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Serial Flash Discoverable Parameters (SFDP) instruction. When the highest address is reached, the address counter rolls over to 0x00h, allowing the read sequence to be continued indefinitely. The Serial Flash Discoverable Parameters (SFDP) instruction is terminated by driving Chip Select (CS#) High. Chip Select (CS#) can be driven High at any time during data output. Any Read Data Bytes at Serial Flash Discoverable Parameters (SFDP) instruction, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

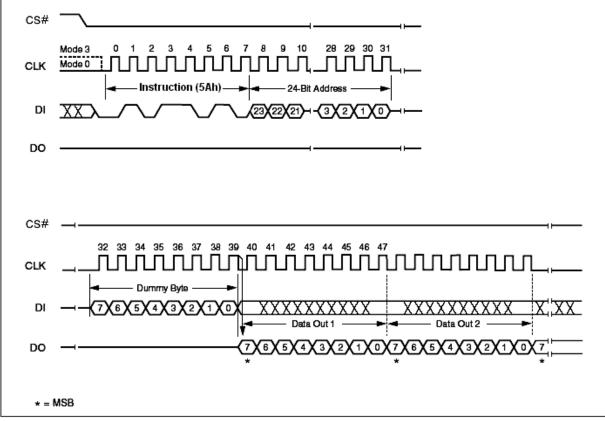


Figure 31. Read SFDP Mode and Unique ID Number Instruction Sequence Diagram

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Table 10. Serial Flash Discoverable Parameters (SFDP) Signature and Parameter Identification Data Value (Advanced Information)

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
	00h	07:00	53h	
	01h	15 : 08	46h	Signature [31:0]:
SFDP Signature	02h	23 : 16	44h	Hex: 50444653
	03h	31 : 24	50h	
SFDP Minor Revision Number	04h	07 : 00	00h	Star from 0x00
SFDP Major Revision Number	05h	15 : 08	01h	Star from 0x01
Number of Parameter Headers (NPH)	06h	23 : 16	00h	1 parameter header
Unused	07h	31 : 24	FFh	Reserved
ID Number	08h	07:00	00h	JEDEC ID
Parameter Table Minor Revision Number	09h	15 : 08	00h	Star from 0x00
Parameter Table Major Revision Number	0Ah	23 : 16	01h	Star from 0x01
Parameter Table Length (in DW)	0Bh	31 : 24	09h	9 DWORDs
Parameter Table Pointer (PTP)	0Ch	07 : 00	30h	
	0Dh	15 : 08	00h	000030h
	0Eh	23 : 16	00h	
Unused	0Fh	31 : 24	FFh	Reserved



Table 11. Parameter ID (0) (Advanced Information) 1/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Block / Sector Erase sizes Identifies the erase granularity for all Flash Components		00 01	01b	00 = reserved 01 = 4KB erase 10 = reserved
Write Granularity		02	1b	11 = 64 KB erase 0 = No, 1 = Yes
Write Enable Instruction Required for Writing to Volatile Status Register	30h	03		00 = N/A
Write Enable Opcode Select for Writing to Volatile Status Register	-	04	00b	01 = use 50h opcode 11 = use 06h opcode
		05		
Unused		06	111b	Reserved
		07		
		08		
		09		
		10		
4 Kilo-Byte Erase Opcode	31h	11	20h	4 KB Erase Support (FFh = not supported)
		12		(FFIT = not supported)
		13 14		
	-	14		
Supports (1-1-2) Fast Read Device supports single input opcode & address and dual output data Fast Read		16	1b	0 = not supported 1 = supported
Address Byte Number of bytes used in addressing for flash array read, write and erase.		17	00b	00 = 3-Byte 01 = 3- or 4-Byte (e.g. defaults to 3-Byte mode; enters 4-Byte mode on command) 10 = 4-Byte 11 = reserved
Supports Double Transfer Rate (DTR) Clocking Indicates the device supports some type of double transfer rate clocking.	32h	19	0b	0 = not supported 1 = supported
Supports (1-2-2) Fast Read Device supports single input opcode, dual input address, and dual output data Fast Read		20	1b	0 = not supported 1 = supported
Supports (1-4-4) Fast Read Device supports single input opcode, quad input address, and quad output data Fast Read		21	1b	0 = not supported 1 = supported
Supports (1-1-4) Fast Read Device supports single input opcode & address and quad output data Fast Read		22	1b	0 = not supported 1 = supported
Unused		23	1b	Reserved
		24		
		25		
		26		
United		27	FFL	Decement
Unused	33h	28	FFh	Reserved
		29		
		30		



Table 11. Parameter ID (0) (Advanced Information) 2/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Flash Memory Density	37h : 34h	31 : 00	001FFFFFh	2 Mbits

Table 11. Parameter ID (0) (Advanced Information) 3/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
		00		
(1-4-4) Fast Read Number of Wait states		01		
(dummy clocks) needed before valid		02	00100b	4 dummy clocks
output	38h	03		
		04		
Quad Input Address Quad Output (1-4-4) Fast Read Number of Mode Bits		05		
		06	010b	8 mode bits
		07		
(1-4-4) Fast Read Opcode	39h	08		
		09	EBh	
		10		
		11		
Opcode for single input opcode, quad input address, and quad output data Fast Read.		12		
		13		
		14		
		15		
		16	01000b	
(1-1-4) Fast Read Number of Wait states		17		
(dummy clocks) needed before valid		18		8 dummy clocks
output	3Ah	19		
		20 21		
(1-1-4) Fast Read Number of Mode Bits		22	000b	Not Supported
		23	auuu	Not Supported
(1-1-4) Fast Read Opcode		20		
Opcode for single input opcode & address and quad output data Fast Read.	3Bh	31 : 24	6Bh	



Table 11. Parameter ID (0) (Advanced Information) 4/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
		00		
(1-1-2) Fast Read Number of Wait states		01		
(dummy clocks) needed before valid		02	01000b	8 dummy clocks
output	3Ch	03		
		04		
(1-1-2) Fast Read Number of Mode Bits		05		
	-	06	000b	Not Supported
		07		
(1-1-2) Fast Read Opcode Opcode for single input opcode & address	3Dh	15 : 08	3Bh	
and dual output data Fast Read.	3011	13.00	3011	
		16		
(1-2-2) Fast Read Number of Wait states		17	00100b	
(dummy clocks) needed before valid		18		4 dummy clocks
output	3Eh	19		-
	3EII	20		
		21		
(1-2-2) Fast Read Number of Mode Bits		22	000b	Not Supported
		23		
(1-2-2) Fast Read Opcode	051			
Opcode for single input opcode, dual input address, and dual output data Fast Read.	3Fh	31 : 24	BBh	

Table 11. Parameter ID (0) (Advanced Information) 5/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment	
Supports (2-2-2) Fast Read Device supports dual input opcode & address and dual output data Fast Read.		00	0b	0 = not supported 1 = supported	
Reserved. These bits default to all 1's		01			
	- 40h	02	111b	Reserved	
		03			
Supports (4-4-4) Fast Read Device supports Quad input opcode & address and quad output data Fast Read.		40h	40n	04	1b
		05			
Reserved. These bits default to all 1's		06	111b	Reserved	
		07			
Reserved. These bits default to all 1's	43h : 41h	31 : 08	FFFFFFh	Reserved	

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Table 11. Parameter ID (0) (Advanced Information) 6/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Reserved. These bits default to all 1's	45h : 44h	15 : 00	FFFFh	Reserved
		16		
(2-2-2) Fast Read Number of Wait states		17		
(dummy clocks) needed before valid output	46h	18	00000b	Not Supported
		19		
		20		
		21		
(2-2-2) Fast Read Number of Mode Bits		22		Not Supported
		23		
(2-2-2) Fast Read Opcode Opcode for dual input opcode & address and dual output data Fast Read.	47h	31 : 24	FFh	Not Supported

Table 11. Parameter ID (0) (Advanced Information) 7/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Reserved. These bits default to all 1's	49h : 48h	15 : 00	FFFFh	Reserved
(4-4-4) Fast Read Number of Wait states (dummy clocks) needed before valid output		16		
		17		
	4Ah	18	00100b 010b	4 dummy clocks
		19		
		20		
		21		
(4-4-4) Fast Read Number of Mode Bits		22		8 mode bits
		23		
(4-4-4) Fast Read Opcode Opcode for quad input opcode/address, quad output data Fast Read.	4Bh	31 : 24	EBh	Must Enter QPI Mode Firstly

Table 11. Parameter ID (0) (Advanced Information) 8/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Sector Type 1 Size	4Ch	07:00	0Ch	4 KB
Sector Type 1 Opcode	4Dh	15 : 08	20h	
Sector Type 2 Size	4Eh	23 : 16	0Fh	32 KB
Sector Type 2 Opcode	4Fh	31 : 24	52h	

Table 11. Parameter ID (0) (Advanced Information) 9/9

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Sector Type 3 Size	50h	07:00	10h	64 KB
Sector Type 3 Opcode	51h	15 : 08	D8h	
Sector Type 4 Size	52h	23 : 16	00h	Not Supported
Sector Type 4 Opcode	53h	31 : 24	FFh	Not Supported

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Read Unique ID Number

The Read Unique ID Number instruction accesses a factory-set read-only 96-bit number that is unique to each device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The Read Unique ID instruction is initiated by driving the CS# pin low and shifting the instruction code "5Ah" followed by a three bytes of addresses, 0x80h, and one byte of dummy clocks. After which, the 96-bit ID is shifted out on the falling edge of CLK.

Table 12. Unique ID Number

Description	Address (h) (Byte Mode)	Address (Bit)	Data	Comment
Unique ID Number	80h : 8Bh	95 : 00	By die	

Power-up Timing

All functionalities and DC specifications are specified for a V_{CC} ramp rate of greater than 1V per 100 ms. See Table 13 and Figure 32 for more information.

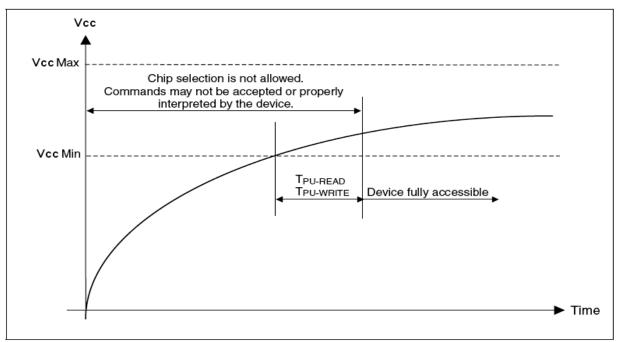


Figure 32. Power-up Timing

Table 13. Power-Up Timing

Symbol	Parameter	Min.	Unit
(1) T _{PU-READ}	V _{CC} Min to Read Operation	100	μs
(1) T _{PU-WRITE}	V _{CC} Min to Write Operation	100	μs

Note:

1. This parameter is measured only for initial qualification and after a design or process change that could affect this parameter.



INITIAL DELIVERY STATE

The device is delivered with the memory array erased: all bits are set to 1 (each byte contains FFh). The Status Register contains 00h (all Status Register bits are 0).

Table 14. DC Characteristics

$(T_A = -40^{\circ}C \text{ to } 85^{\circ}C \text{ (V grade)} / -40^{\circ}C \text{ to } 105^{\circ}C \text{ (VA grade)}; V_{CC} = 2.7-3.6V)$	$(T_{A} = -40^{\circ}C tc)$	0 85°C (V grade)	/ -40°C to 105°C (VA	A grade); $V_{CC} = 2.7-3.6V$
--	-----------------------------	------------------	----------------------	-------------------------------

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
ILI	Input Leakage Current			-	1	± 2	μA
I _{LO}	Output Leakage Current			-	1	± 2	μA
laa	Standby Current	$CS\# = V_{CC},$	T _A (V grade)	-	1	20	μΑ
I _{CC1}	Standby Current	$V_{IN} = V_{SS} \text{ or } V_{CC}$	T _A (VA grade)	-	1	25	μΑ
	Deep Power-down	$CS\# = V_{CC},$	T _A (V grade)	-	1	20	μA
I _{CC2}	Current	$V_{IN} = V_{SS} \text{ or } V_{CC}$	T _A (VA grade)	-	1	25	μΑ
		$CLK = 0.1 V_{CC} / 0.9$ $V_{CC} \text{ at } 104MHz,$ $DQ = \text{open}$		-	5	10	mA
	Operating Current		T _A (VA grade)	-	6	13	mA
I _{CC3}	(READ) CLK = 0.1 V _{CC} / 0. V _{CC} at 104MHz	$\begin{array}{c} \text{CLK} = 0.1 \ \text{V}_{\text{CC}} \ \text{/} \ 0.9 \\ \text{V}_{\text{CC}} \ \text{at} \ 104 \text{MHz} \ \text{in} \end{array}$	T _A (V grade)	-	14	18	mA
		Quad mode, DQ = open	T _A (VA grade)	-	15	21	mA
1	Operating Current (DD)	08# V	T _A (V grade)	-	9	20	mA
I _{CC4}	Operating Current (PP)	$CS\# = V_{CC}$	T _A (VA grade)	-	12	23	mA
1	Operating Current	$CS\# = V_{CC}$	T _A (V grade)	-	-	12	mA
I _{CC5}	(WRSR)	$CO# = V_{CC}$	T _A (VA grade)	-	-	14	mA
I _{CC6} ¹	Operating Current (SE)	CS# = V _{CC}	T _A (V grade)	-	9	20	mA
ICC6	Operating Current (SE)	CO# = VCC	T _A (VA grade)	-	12	23	mA
I _{CC7} ¹	Operating Current (BE)	$CS\# = V_{CC}$	T _A (V grade)	-	9	20	mA
ICC7		$C3\# = V_{CC}$	T _A (VA grade)	-	12	23	mA
V _{IL}	Input Low Voltage			- 0.5		0.2 V _{CC}	V
V _{IH}	Input High Voltage			0.7 V _{CC}		V _{CC} +0.4	V
V _{OL}	Output Low Voltage	$I_{OL} = 100 \ \mu A, \ V_{CC} = V_{CC}$	c Min.	-		0.3	V
V _{OH}	Output High Voltage	I _{OH} = -100 µA, V _{CC} =V	_{cc} Min.	V _{CC} -0.2		-	V

Note:

1. Erase current measure on all cells = '0' state.



Table 15. AC Measurement Conditions

Symbol	Parameter	Min. Max.		Unit
CL	Load Capacitance	3	pF	
	Input Rise and Fall Times		5	ns
	Input Pulse Voltages 0.2V _{CC} to 0.8V _{CC}		V	
	Input Timing Reference Voltages	$0.3V_{CC}$ to $0.7V_{CC}$		V
	Output Timing Reference Voltages	; / 2	V	

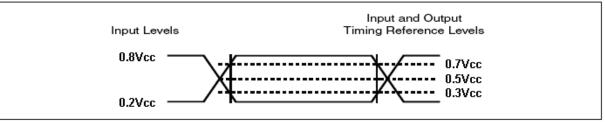


Figure 33. AC Measurement I/O Waveform



Table 16. AC Characteristics

Symbol	Alt	Parameter		Min	Тур	Max	Unit
F _R	f _C	FAST_READ, QPP, PP, SE, HBE WREN, WRDI, WRSR, RDSR, RI Fast Read and Quad I/O Fast Rea	D.C.	-	104	MHz	
f _R		Serial Clock Frequency for READ	D.C.	-	50	MHz	
t _{CH} 1		Serial Clock High Time		3.5	-	-	ns
t _{CL} ¹		Serial Clock Low Time		3.5	-	-	ns
t _{CLCH} ²		Serial Clock Rise Time (Slew Rate)	0.1	-	-	V / ns
t _{CHCL} ²		Serial Clock Fall Time (Slew Rate)	, ,				V / ns
t _{SLCH}	t _{CSS}	CS# Active Setup Time (Relative to	5	-	-	ns	
t _{CHSH}		CS# Active Hold Time (Relative to	CLK)	5	-	-	ns
t _{SHCH}		CS# Not Active Setup Time (Relati	ve to CLK)	5	-	-	ns
t _{CHSL}		CS# Not Active Hold Time (Relativ	e to CLK)	5	-	-	ns
t _{SHSL}	t _{CSH}	CS# High	,	30	-	_	ns
t _{SHQZ} ²	t _{DIS}	Output Disable Time		-	-	6	ns
t _{CLQX}	t _{HO}	Output Hold Time		0	-	-	ns
t _{DVCH}	t _{DSU}	Data In Setup Time	•				ns
t _{CHDX}	t _{DH}	Data In Hold Time	2	_	_	ns	
t _{HLCH}	DH	HOLD# Low Setup Time (Relative	5			ns	
t _{HHCH}		HOLD# High Setup Time (Relative	5			ns	
t _{CHHH}			HOLD# Low Hold Time (Relative to CLK)				ns
		HOLD# High Hold Time (Relative t	,	5 5			ns
t _{CHHL}	t	HOLD# Low to High-Z Output	UCER)	5		6	
'HLQZ	t _{HZ}						ns
t _{HHQX} ²	t _{LZ}	HOLD# High to Low-Z Output				6	ns
t _{CLQV}	t _v	Output Valid from CLK for 30 pF Output Valid from CLK for 15 pF	T _A (V grade)	-	-	8 6	ns
CLQV	v	Output Valid from CLK for 30 pF Output Valid from CLK for 15 pF	T _A (VA grade)	-	-	9 7	ns
t _{WHSL} ³		Write Protect Setup Time before C	S# Low	20	-	-	ns
t _{SHWL} ³		Write Protect Hold Time after CS#	High	100	-	-	ns
t _{DP} ²		CS# High to Deep Power-down Mo	ode	-	-	3	μs
t _{RES1} ²		CS# High to Standby Mode withou Signature read	t Electronic	-	-	3	μs
t _{RES2} ²		CS# High to Standby Mode with El Signature read	ectronic	-	-	1.8	μs
t _W		Write Status Register Cycle Time	T _A (V grade) T _A (VA grade)	-	4	30 40	ms
			T_A (VA grade) T_A (V grade)	_	5 0.5	40 3	ms ms
t _{PP}		Page Programming Time	T _A (V grade) T _A (VA grade)	-	0.3	4	ms
			T _A (V grade)	_	40	300	ms
t _{SE}		Sector Erase Time (4K)	T _A (VA grade)		50	400	ms
			T _A (V grade)	-	0.12	1	s
t _{HBE}		32KB Block Erase Time	T _A (VA grade)		0.15	1.3	S
+			T _A (V grade)	-	0.15	2	s
t _{BE}		64KB Block Erase Time	T _A (VA grade)		0.2	2.3	s

(T_A = -40 $^\circ\text{C}$ to 85 $^\circ\text{C}$ (V grade) / -40 $^\circ\text{C}$ to 105 $^\circ\text{C}$ (VA grade); V_{CC} = 2.7-3.6V)

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EN25F20A(2N) Automotive Grade

t _{CE} C		Chip Erase Time		T _A (V grade)	-	1	4	S
				T _A (VA grade)		1.5	5	S
+			WIP = write ope	eration	-	-	28	μs
^L SR	Latency	WIP = not in write operation		-	-	0	μs	

Note:

- 1. $t_{CH} + t_{CL}$ must be greater than or equal to 1/ f_C 2. Value guaranteed by characterization, not 100% tested in production.
- 3. Only applicable as a constraint for a Write status Register instruction when Status Register Protect Bit is set at 1.



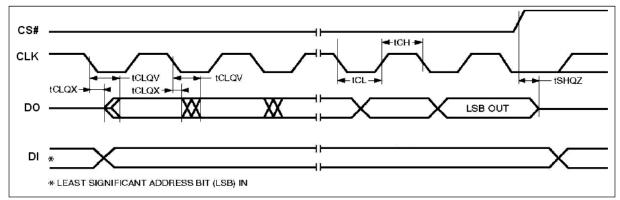


Figure 34. Serial Output Timing

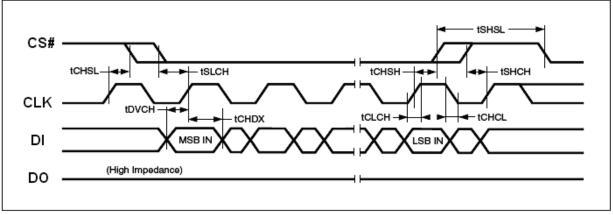


Figure 35. Input Timing



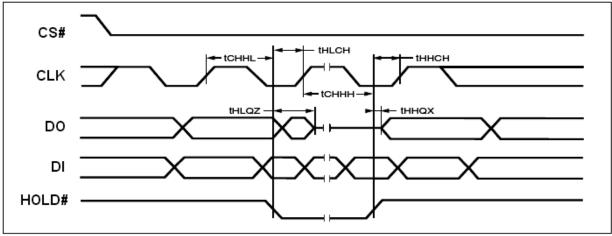


Figure 36. Hold Timing

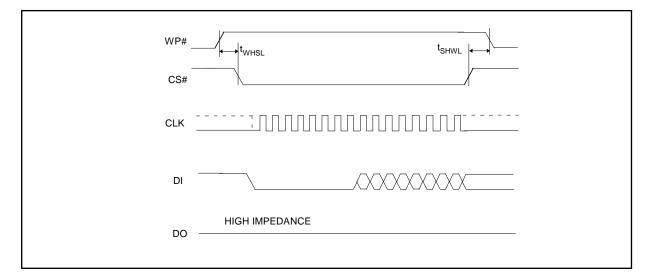


Figure 37: Write Protect setup and hold timing during WRSR when SRP = 1



ABSOLUTE MAXIMUM RATINGS

Stresses above the values so mentioned above may cause permanent damage to the device. These values are for a stress rating only and do not imply that the device should be operated at conditions up to or above these values. Exposure of the device to the maximum rating values for extended periods of time may adversely affect the device reliability.

Parameter	Value	Unit
Storage Temperature	-65 to +150	°C
Output Short Circuit Current ¹	200	mA
Input and Output Voltage (with respect to ground) ²	-0.5 to +4.0	V
Vcc	-0.5 to +4.0	V

Note:

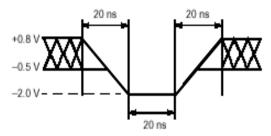
- 1. No more than one output shorted at a time. Duration of the short circuit should not be greater than one second.
- 2. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, inputs may undershoot V_{SS} to -1.0V for periods of up to 50ns and to -2.0V for periods of up to 20ns. See figure below. Maximum DC voltage on output and I/O pins is V_{CC} + 0.5V. During voltage transitions, outputs may overshoot to V_{CC} + 1.5V for periods up to 20ns. See figure below.

RECOMMENDED OPERATING RANGES

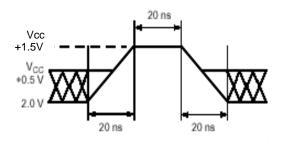
Parameter	Value	Unit
Ambient Operating Temperature Automative Devices	-40 to 85 (V grade)	•
Ambient Operating Temperature Automotive Devices	-40 to 105 (VA grade)	°C
Operating Supply Voltage V _{CC}	Full: 2.7-3.6V	V

Note:

1. Recommended Operating Ranges define those limits between which the functionality of the device is guaranteed.



Maximum Negative Overshoot Waveform



Maximum Positive Overshoot Waveform



Table 17. CAPACITANCE

 $(V_{CC} = 2.7-3.6V)$

Parameter Symbol	Parameter Description	Test Setup	Max	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0$	6	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	8	pF

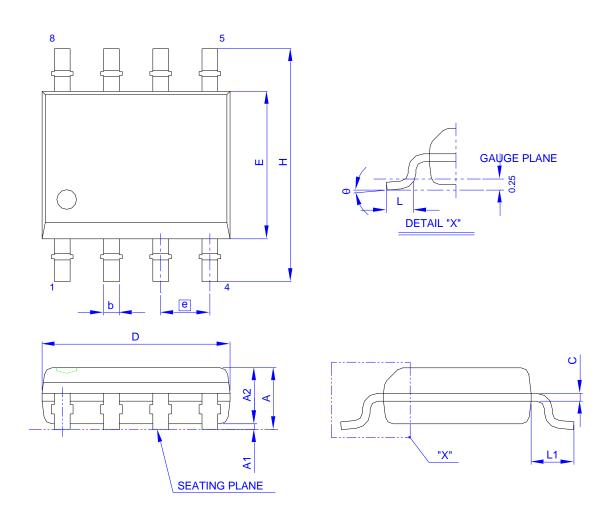
Note: Sampled only, not 100% tested, at $T_A = 25^{\circ}C$ and a frequency of 20MHz.

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PACKAGE MECHANICAL

Figure 38. SOP 8 (150 mil)



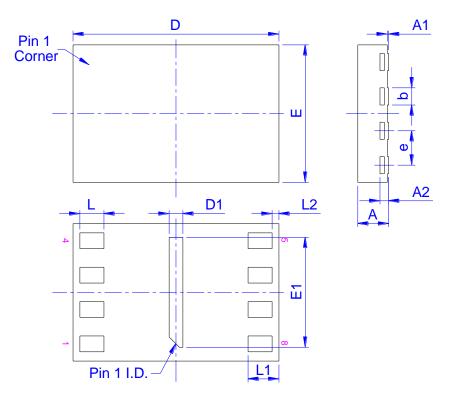
Symbol	Dime	ension in	mm	Dime	nsion in i	nch	Symbol	Dime	ension in	mm	Dime	ension in	inch
Symbol	Min	Norm	Max	Min	Norm	Max	Symbol	Min	Norm	Max	Min	Norm	Max
Α	1.35	1.60	1.75	0.053	0.063	0.069	D	4.80	4.90	5.00	0.189	0.193	0.197
A ₁	0.10	0.15	0.25	0.004	0.006	0.010	Е	3.80	3.90	4.00	0.150	0.154	0.157
A ₂	1.25	1.45	1.55	0.049	0.057	0.061	L	0.40	0.66	0.86	0.016	0.026	0.034
b	0.33	0.406	0.51	0.013	0.016	0.020	е		1.27 BSC	;	0	.050 BS	C
с	0.19	0.203	0.25	0.0075	0.008	0.010	L ₁	1.00	1.05	1.10	0.039	0.041	0.043
Н	5.80	6.00	6.20	0.228	0.236	0.244	θ	0°		8°	0°		8°

Controlling dimension : millimenter

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Figure 39. USON (8L 2x3x0.45mm)

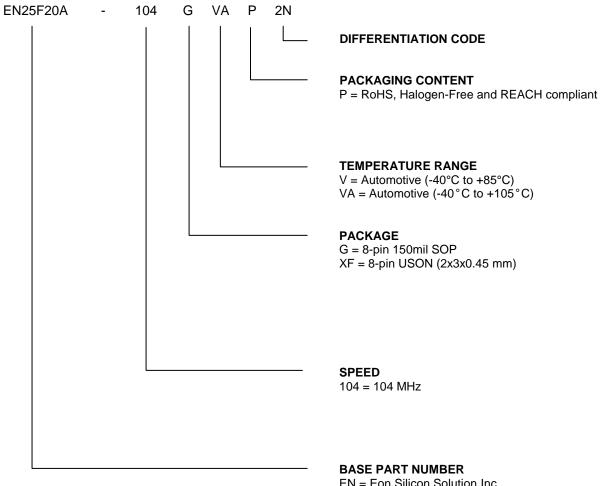


Symbol	D	imension in m	m					
	Min.	Norm.	Max.					
Α	0.40	0.45	0.50					
A1	0.00	-	0.05					
A2		0.152 REF						
b	0.20	0.25	0.30					
D	2.90	3.00	3.10					
D1	0.10	0.20	0.30					
E	1.90	2.00	2.10					
E1	1.50	1.60	1.70					
е		0.50 BSC						
L	0.30	-	-					
L1	0.40	0.45	0.50					
L2	-	-	0.15					

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ORDERING INFORMATION



EN = Eon Silicon Solution Inc. 25F = 3V Serial Flash with 4KB Uniform-Sector, Dual and Quad I/O 20 = 2 Megabit (256K x 8) A = version identifier



Revisions List

Revision No	Description	Date
1.0	Initial Release	2020/05/27
1.1	Delete Plastic Packages Temperature	2020/10/15
1.2	 Add Important Notice Correct SOP8 150mil packing dimension Remove VSOP8 150mil, USON8 2x3x0.55 and VDFN/ WSON8 (6x5mm) package 	2020/12/09



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